

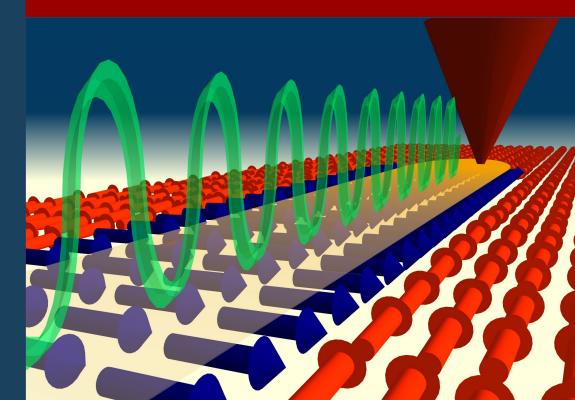


Thermal Scanning Probe Lithography

Edoardo Albisetti Dipartimento di Fisica - Politecnico di Milano

30/6/21, NanoLito 2021, University of Salamanca

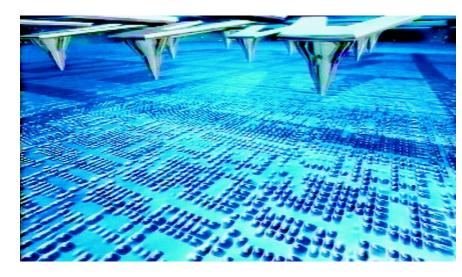
Nanolito 2021: SUMMER SCHOOL IN BASICS AND APPLICATIONS OF NANOLITHOGRAPHY

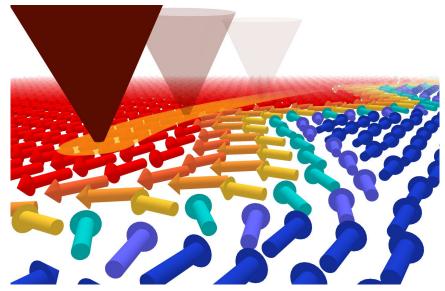


Outlook

- Scanning Probe Microscopy / Lithography
- **Brief history of t-SPL: from milli-pedes to nano-structures**
- **Experimental: features and limitations of t-SPL**

- Applications:
- 1) REMOVAL Direct sublimation of organic resists / lithography
- 2) «CHEMICAL conversion» at the nanoscale
- 3) «PHYSICAL conversion»: t-SPL for magnetism

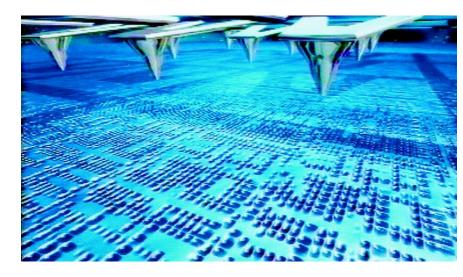


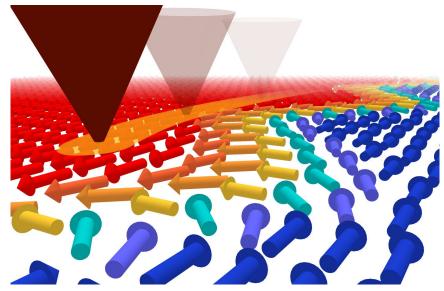


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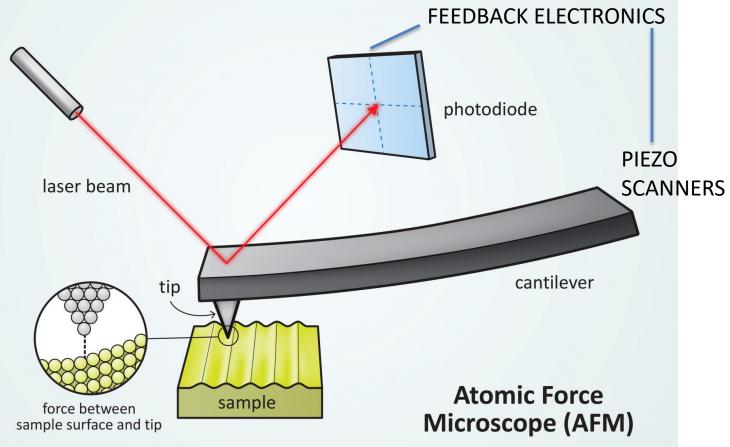
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3

Scanning Probe Microscopy



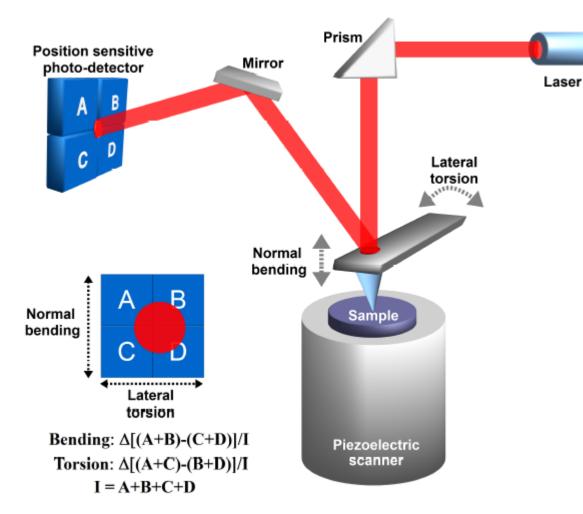
Atomic Force Microscopy

Scanning Probe Microscopy modes: Magnetic Force Microscopy (MFM) Lateral Force Microscopy (LFM) Intermitant and non-contact AFM Force Modulation Microscopy (FMM) Electrostatic Force Microscopy (EFM)

Depending on the tip-sample interaction

. . .

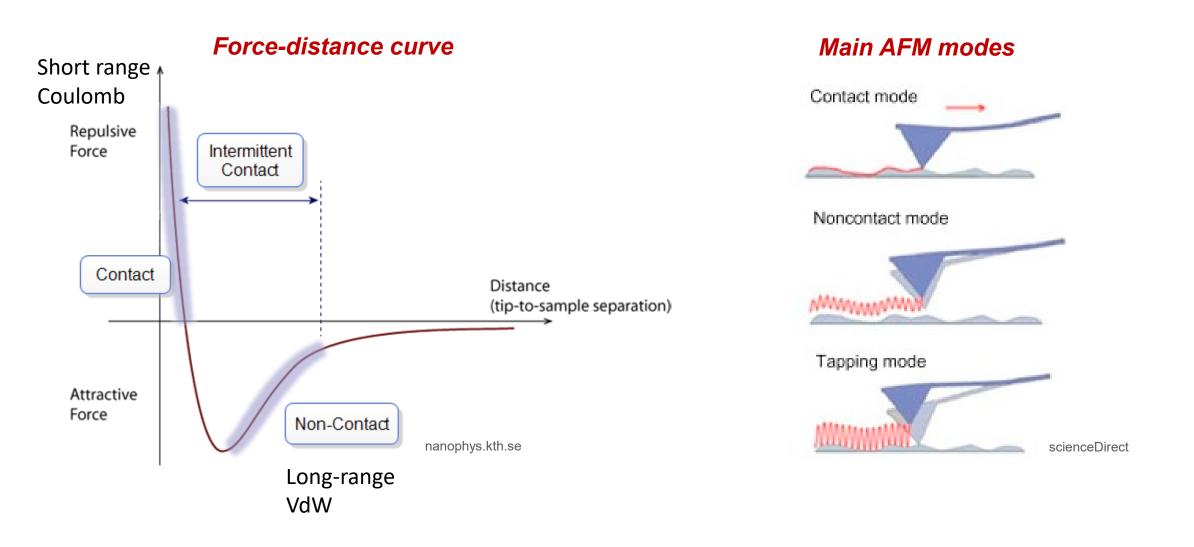
AFM force detection mechanism



Debin Wang, Ph.D. Thesis GeorgiaTech 2010

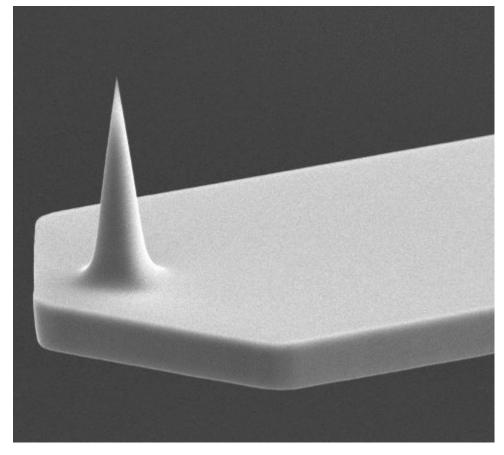
Bending + Torsion force detection A four-quadrant position sensitive photo-detector is used to detect the vertical bending and torsion of the cantilever to measure the normal and lateral forces.

AFM tip-sample interaction



AFM Standard Scanning Probes

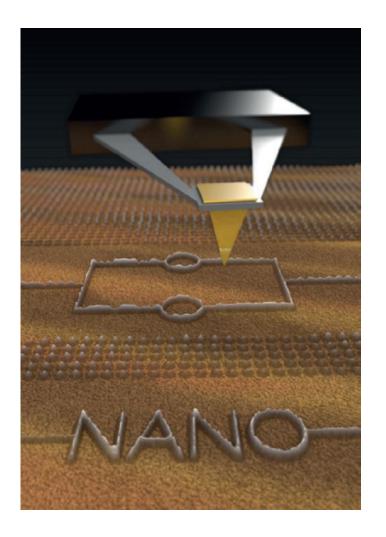




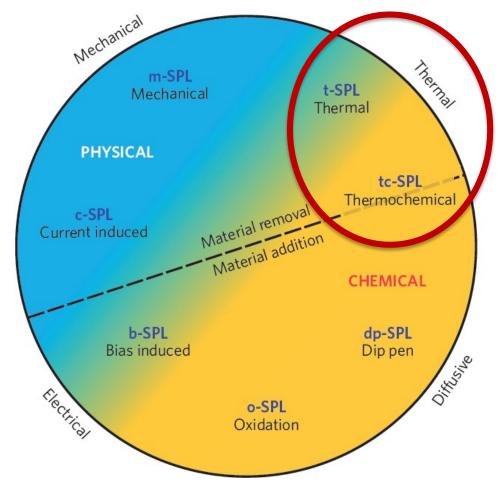
Material: Si, Si3N4 Shape: pyramidal, conical tip Typical Dimensions: $1-4 \ \mu m \ \downarrow \ 100-200 \ \mu m \ 100-200 \ \mu m \ 100 \ \mu m$

Spring constant (k): 0.1-10N/m Resonant frequency: 10 kHz-1 MHz + different coating depending on the application (magnetic, conductive..)

Scanning Probe Lithography



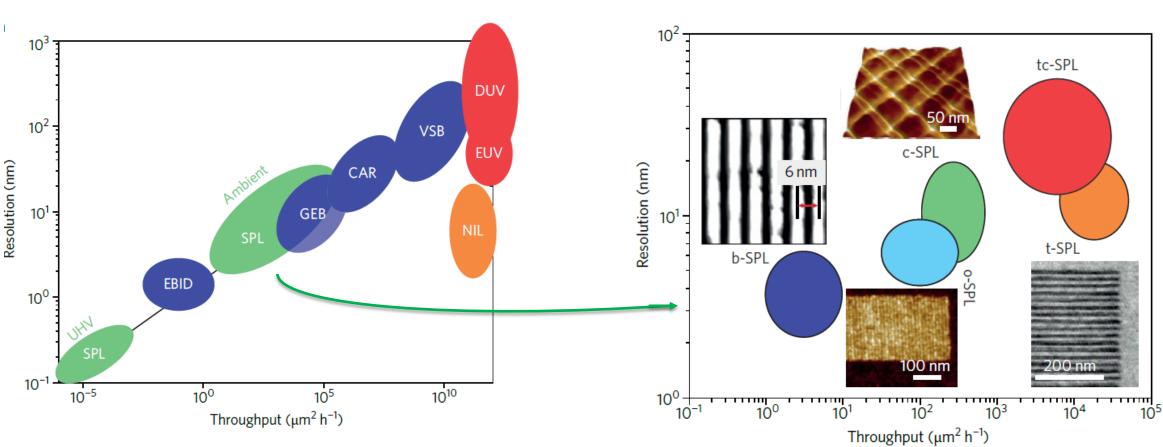
SPL modes



Garcia et al., Nat. Nanotech. 9, 577–587 (2014)

30/6/2021 NanoLito 2021, University of Salamanca

Scanning Probe Lithography: resolution vs throughput



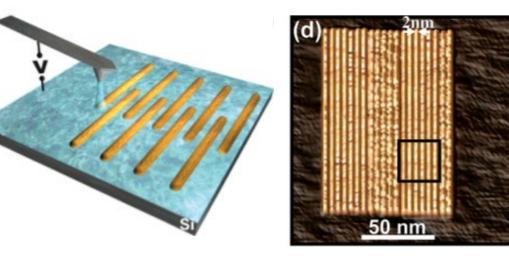
SPL vs others

SPL methods

Garcia et al., Nat. Nanotech. 9, 577–587 (2014)

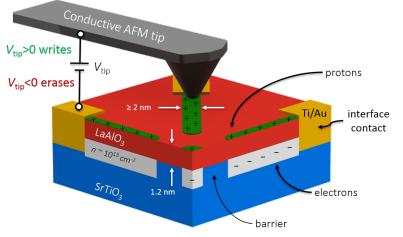
Bias-Scanning Probe Lithography

b-SPL induced deposition

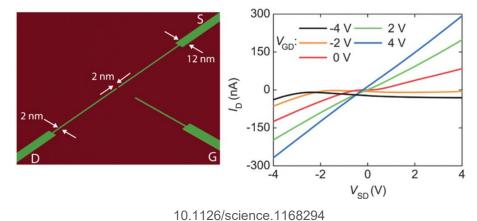


Formation of a nanoscale octane meniscus between a sharp conductive protrusion and a silicon (100) surface. Bias pulse-induced polymerization.

b-SPL conductive nanowires at LAO / STO



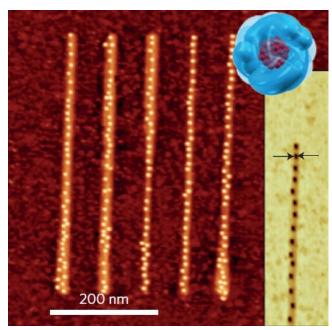
AFM tip moving above LaAlO3-SrTiO3 heterostructure, removing oxygen-containing ions and locally changing the charge state of the surface.



Nano Lett. 2007, 7, 7, 1846–1850

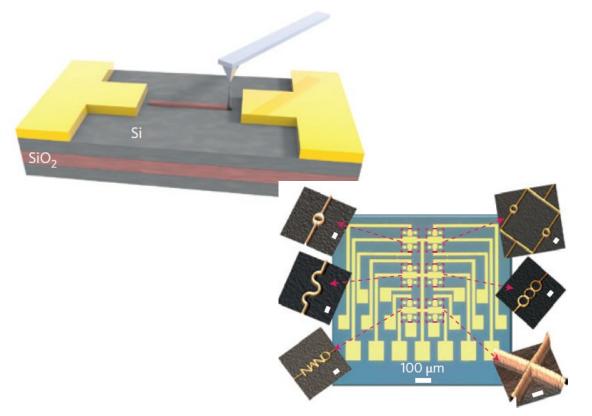
Oxidation-Scanning Probe Lithography

o-SPL functionalization & molecular architectures



Ferritin Single-molecule functionalization

o-SPL SiO2 nanomasks



Selective oxidation and/or complete removal of selfassembled monolayers and subsequent surface functionalization of the oxidized region.

Martinez, R. V. et al. Adv. Mater. 22, 588–591 (2010).

The fabrication of a silicon nanowire transistor involves the patterning of a narrow oxide mask on top of the active layer of a silicon-on-insulator substrate.

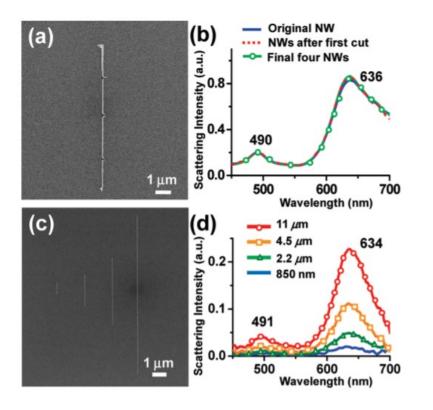
Martinez, R. V., Martinez, J. & Garcia, R. Nanotechnology 21, 245301 (2010).

Thermal Scanning Probe Lithography

Mechanical-Scanning Probe Lithography

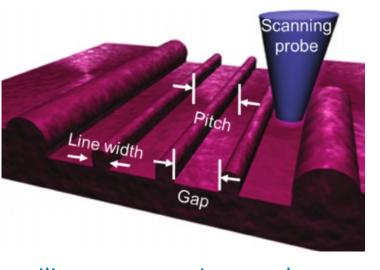
Mechanical SPL (nanomachining) uses the mechanical force exerted by the tip to induce the selective removal of material from a surface.

NW cutting for plasmonics (LSPR)



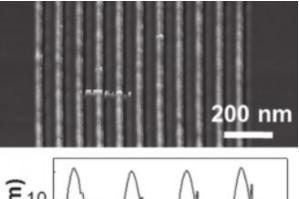
J. Phys. Chem. C, Vol. 114, No. 23, 2010

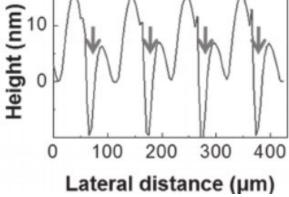
«Plowing» polymers



utilizes a scanning probe as a polymer-coated plow on а surface to generate ridges that can serve as narrow etch masks.

PMMA polymer



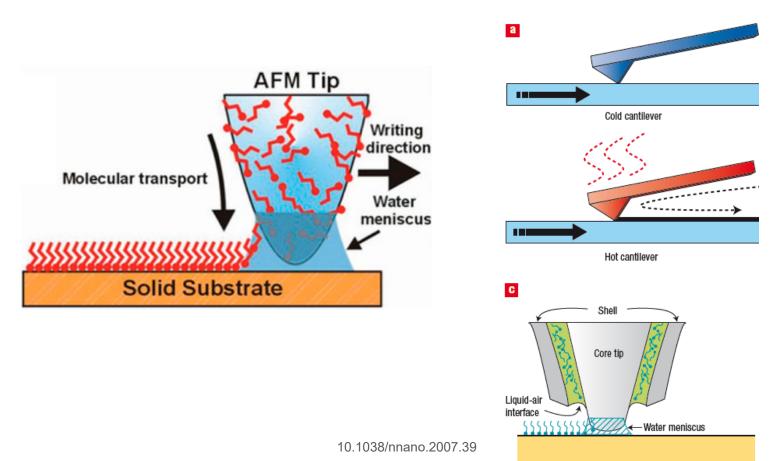


Small 2013, 9, No. 18, 3058-3062

Dip pen-SPL

Direct transport of molecules to surfaces, much like the transfer of ink from a macroscopic dip-pen to paper (sub-100 nm scale)

Dip-pen nanolithography & thermal dip-pen nanolithography



Examples of Inks

Protein, peptide, DNA, Hydrogels, Sol gels, Conductive inks, Lipids, Silanes (liquid phase) written to glass or silicon

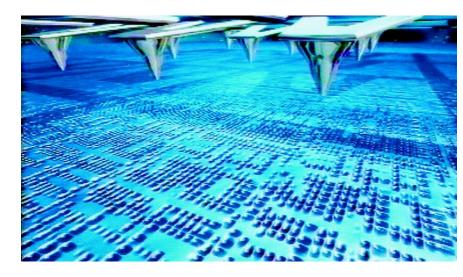
Thermal DPN: AFM cantilever whose tip is coated with a solid 'ink'. When the tip is hot enough, the ink melts and flows onto the substrate.

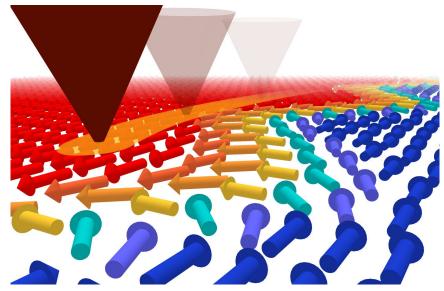
30/6/2021

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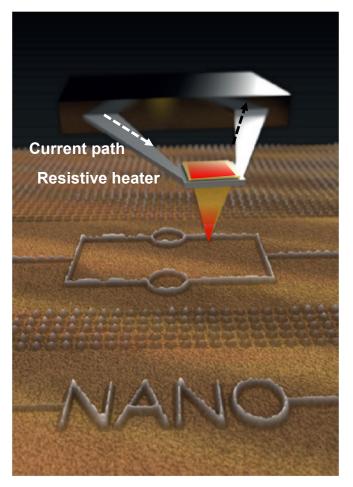
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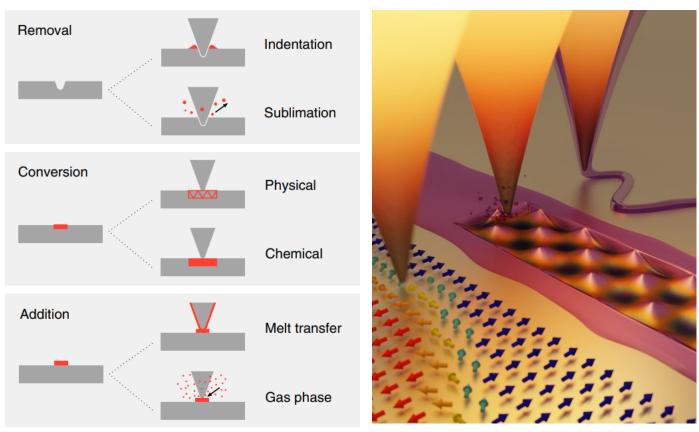


Thermally Assisted Scanning Probe Lithography (t-SPL)

Working principle



Garcia et al., Nat. Nanotech. 9, 577-587 (2014)

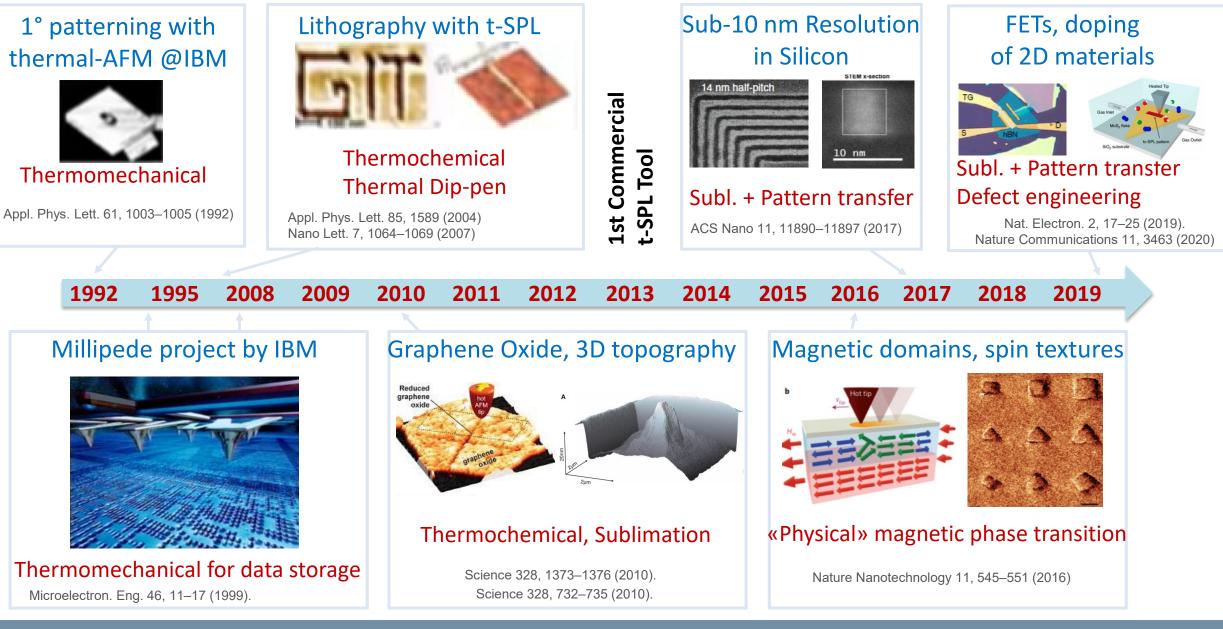


Howell et al. Microsystems & Nanoengineering (2020) 6:21

- Sub-10 nm spatial resolution
- Microsecond timescale
- Precise control of temperature (up to 1200°C) / duration (from few us/px)

Heat as a localized universal stimulus

A brief history of t-SPL

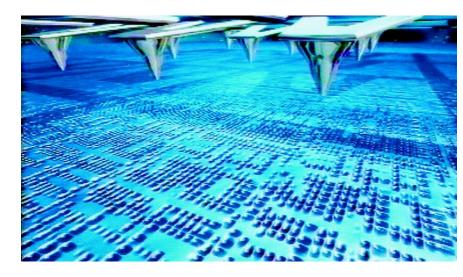


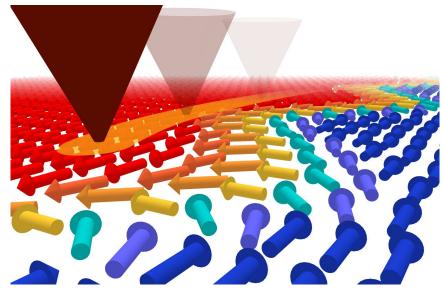
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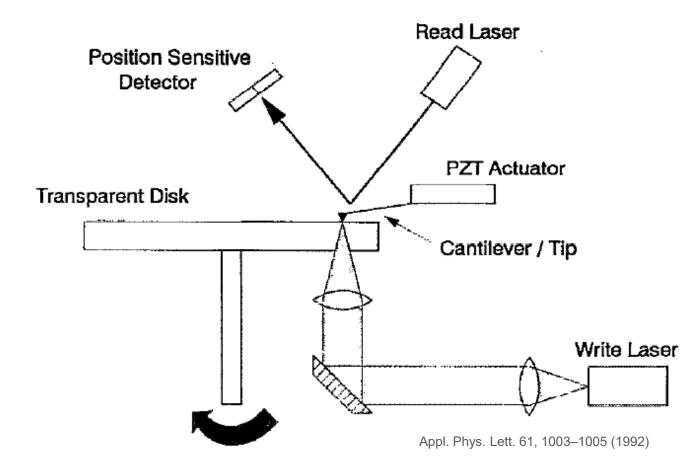
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Thermal cantilevers #1: laser heating on standard AFM tip

Conventional AFM tip, heated by a laser focused on the cantilever

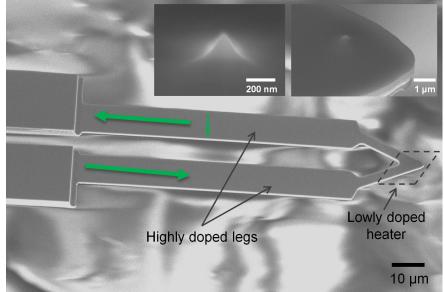


Pros / cons

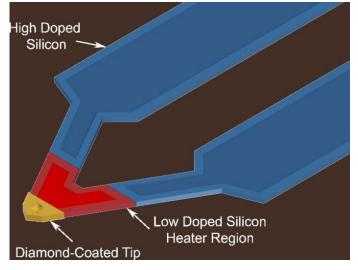
- + Uses standard AFM tips
- Hard to scale and integrate
- Complex setup (laser, lenses, focusing..)

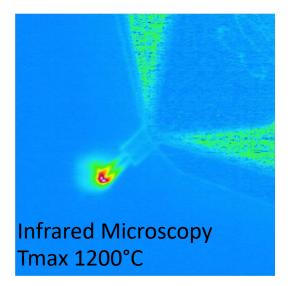
18

Thermal cantilevers #2: resistive heating for writing



D. Wang Ph.D. Thesis, GeorgiaTech 2010





Microfabricated AFM tip, with a resistive heater located on top of the tip, which can be heated controllably via Joule effect. The sensing is performed via conventional optical lever + photodetector

Pros / cons

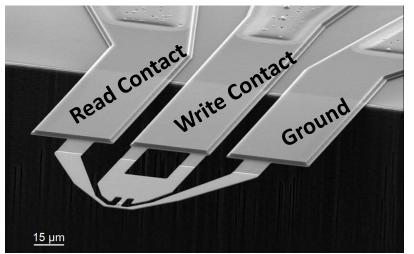
- + Integrated
- + Highly controlled temperature
- Complex fabrication with respect to standard TIP
- Hardly scalable (reading is still via laser)

Fletcher et al., ACS Nano (2010) 4:3338

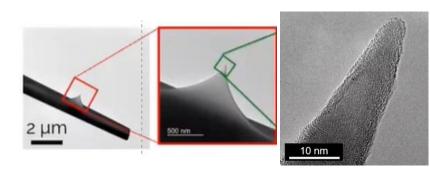
19

Thermal cantilevers #3: resistive heating for writing AND reading

"Millipede concept". Microfabricated AFM tip, with a resistive heater located on top of the tip, which can be heated controllably via Joule effect. The sensing is performed via a second resistive heater which is used as a distance sensor (resistance changes when approaching the surface).

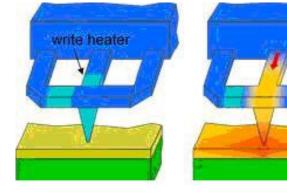


Quantum Design

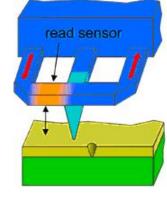


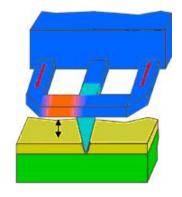
Heidelberg Instruments

Writing operation

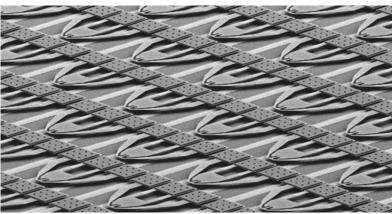


Reading operation





Parallelization

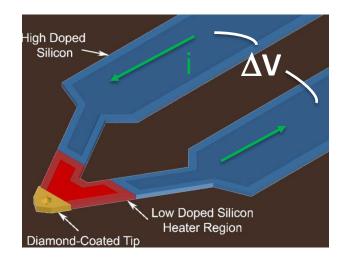


Pros / cons

- + Integrated
- + Controlled temperature
- + Multiplexing capability
- Complex fabrication with respect to standard TIP

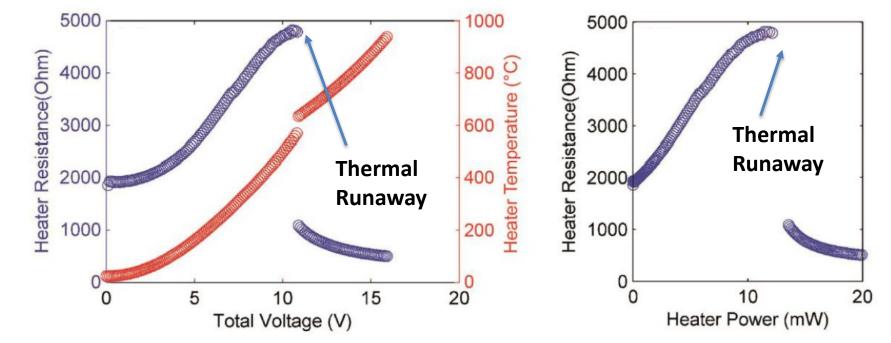
Thermal cantilevers: thermal characteristics

In semiconducting Si, the intrinsic carrier density varies widely with temperature. When the temperature of the heater region reaches a certain level (Ti), the intrinsic carrier density in the silicon exceeds the dopant carrier density. Above Ti, the extra carriers that become available cause the heater region to decrease in resistance, which in turn allows more current to flow, thereby generating more resistive heating (P = Vi). $T_{H} = RT + \frac{T_{i} - RT}{P_{i}}P_{H}$ Ti around 550°C

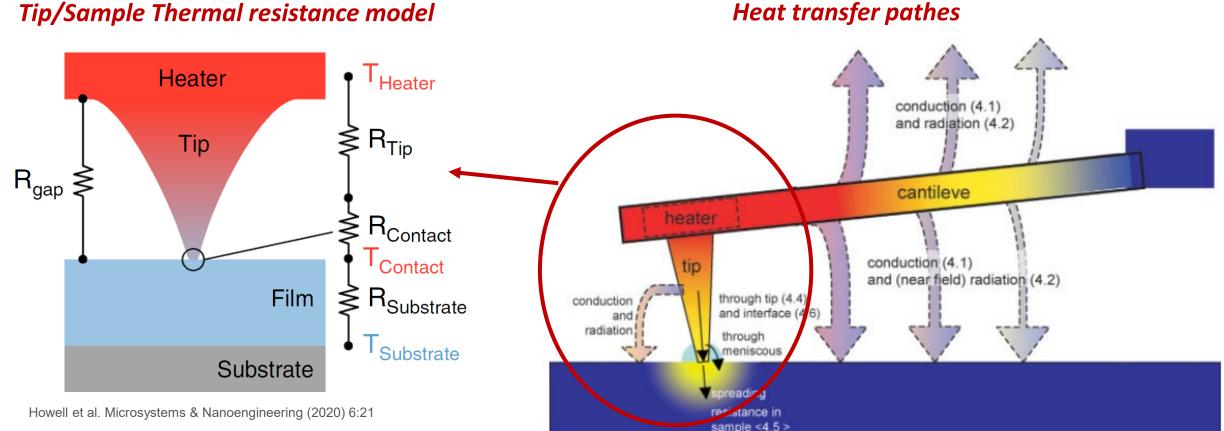


Applied Voltage vs Resistance / Temp

Power vs Resistance



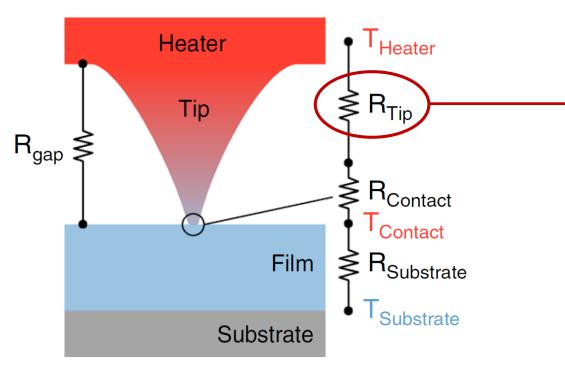
Fletcher et al., ACS Nano (2010) 4:3338



Tip/Sample Thermal resistance model

Nanotechnology 121-169, https://doi.org/10.1002/9783527628155.nanotech066

Tip/Sample Thermal resistance model



Howell et al. Microsystems & Nanoengineering (2020) 6:21

$$C = \frac{T_{cont}}{T_{heat}} = \frac{R_{subs}}{R_{tip} + R_{cont} + R_{subs}} \quad C$$

Conductance of the phonons within the silicon tip and from the layer of native oxide covering it. R > Rbulk

- Enhanced phonon scattering with boundary surfaces.
- Reduction of the cross section area towards the tip apex (T over 90% of R_{tip} occurs at the first 10% of the tip length).

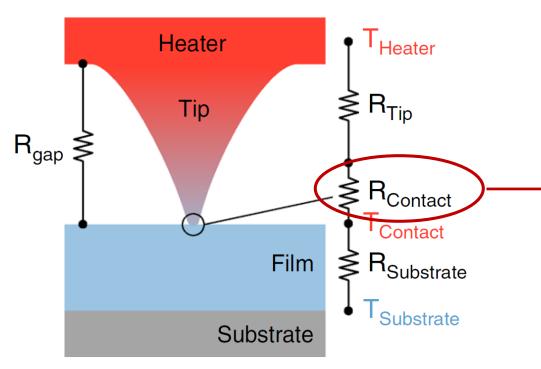
Sharp tips, lower opening angle -> Lower T

$$k = \frac{1}{3} C v \left(\Lambda_0^{-1} + d^{-1} \right)^{-1}$$

C heat capacity v phonon speed Gamma0 phonon mean free path d diameter

23

Tip/Sample Thermal resistance model

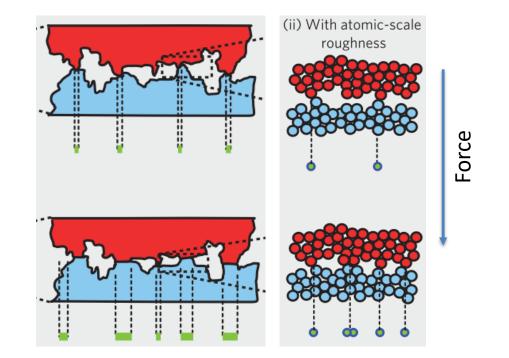


Howell et al. Microsystems & Nanoengineering (2020) 6:21

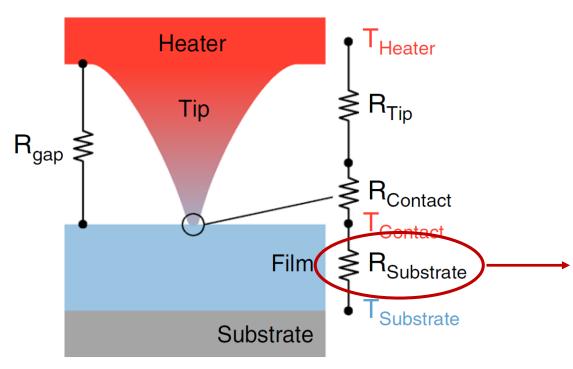
$$C = \frac{T_{cont}}{T_{heat}} = \frac{R_{subs}}{R_{tip} + R_{cont} + R_{subs}}$$

Quantum thermal transport across individual contact points. The number of contact points increases with the applied force + Thermal conduction through meniscus. Extremely complex to predict!

Approx: a single-asperity contact characterized by a contact diameter d0.



Tip/Sample Thermal resistance model



Howell et al. Microsystems & Nanoengineering (2020) 6:21

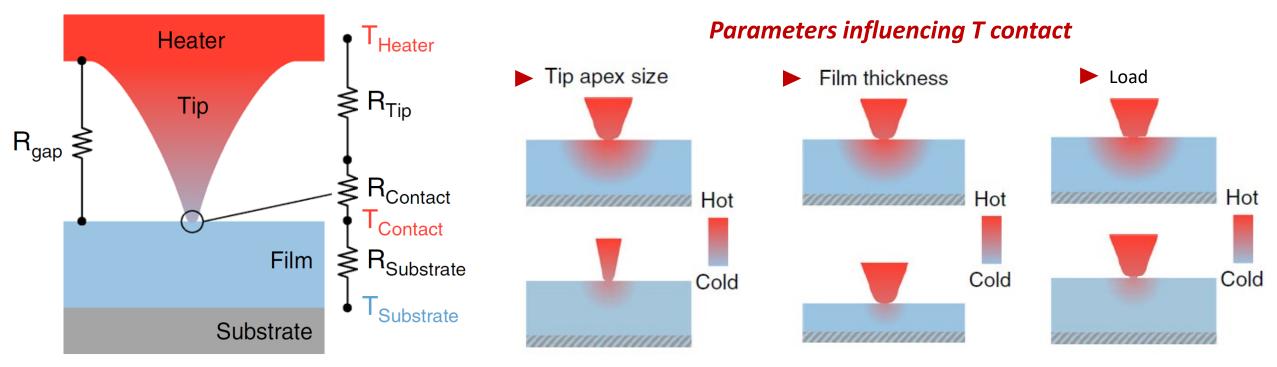
$$C = \frac{T_{cont}}{T_{heat}} = \frac{R_{subs}}{R_{tip} + R_{cont} + R_{subs}}$$

Well understood and depends on the thermal conductance of the film, film thickness, contact point diameter, substrate thermal conductance.

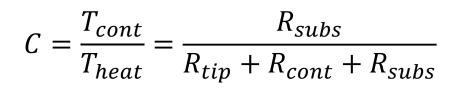
$$R_{\rm sp} = \frac{1}{2\kappa_s d_0} - \frac{1}{2\pi\kappa_s t} \log\left(\frac{2}{1 + \kappa_s/\kappa_{\rm sub}}\right)$$

ks thermal cond film d0 contact diameter t film thickness ksub thermal cond substrate

Tip/Sample Thermal resistance model



Howell et al. Microsystems & Nanoengineering (2020) 6:21



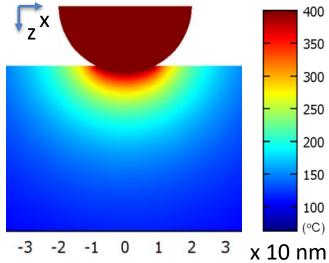
Film thermal conductivity (Higher K: lower T, higher resolution)

Howell et al. Microsystems & Nanoengineering (2020) 6:21

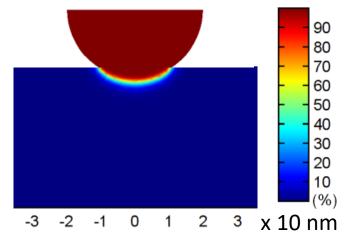
Influence of the *temperature* on the conversion efficiency

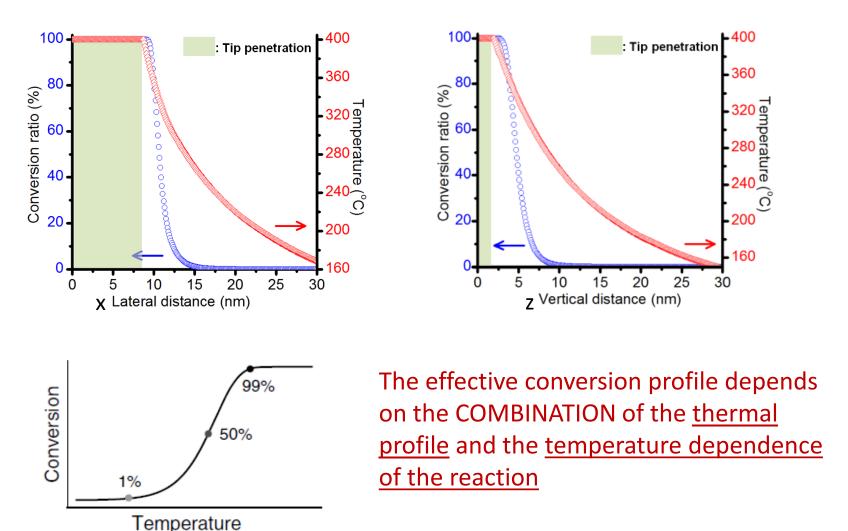
Finite element modelling (FEM) of the temperature and amine conversion profile inside a carbamate copolymer.

Temperature vs distance



Conversion ratio vs distance





Debin Wang, Ph.D. Thesis GeorgiaTech 2010

Influence of the patterning <u>speed</u> on the conversion efficiency

Controlled thermally-induced deprotection of amine groups from a polymeric film

(a) Conversion efficiency at different speed Speed (µm/s) 10³ 10² 10 (C Experiment 1.00 Model Concentration Relative (10 12 0.00 10 10² 10³ 104

Fixed temperature, varying speed

Speed (µm/s)

Higher speed exposes the system to the temperature profile for less time, resulting in a decreased rate of reaction.

Keith Carroll, Ph.D. Thesis GeorgiaTech 2013

Concentration Concentration 0.50

Relative 55'0

0.00

00

um/s 00 um/s mm/s

speed

8

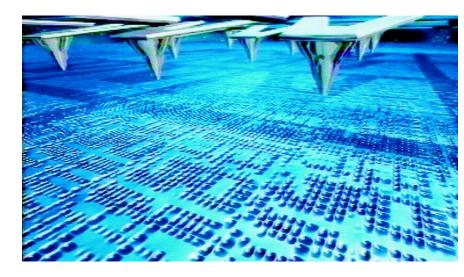
Power (mW)

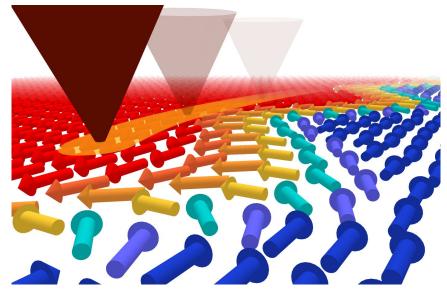
6

Outlook

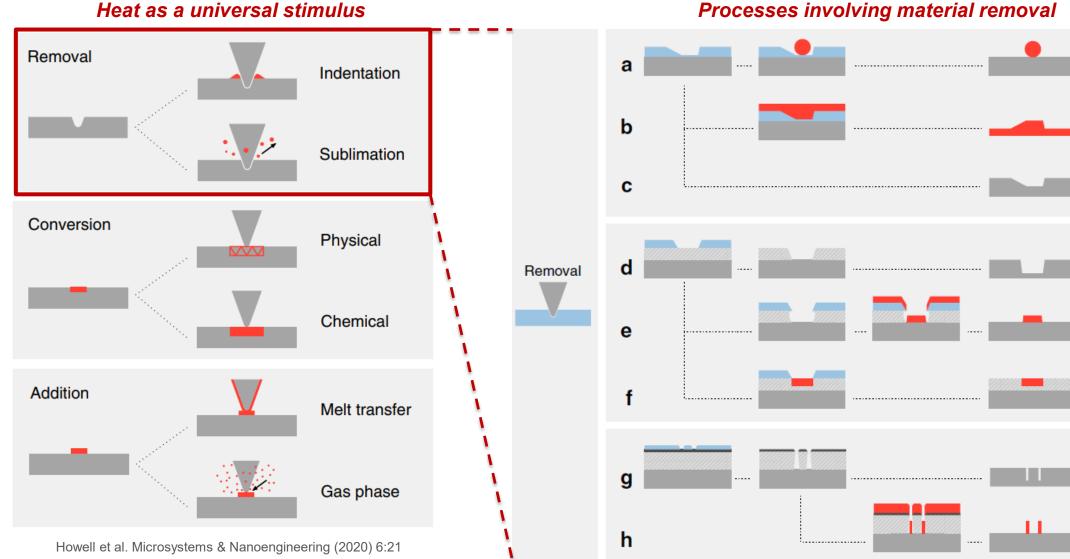
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Applications of t-SPL: material removal



Processes involving material removal

Guiding, trapping

Molding, plating

Etching

Lift-off

activation

Deep etching

Selective surface

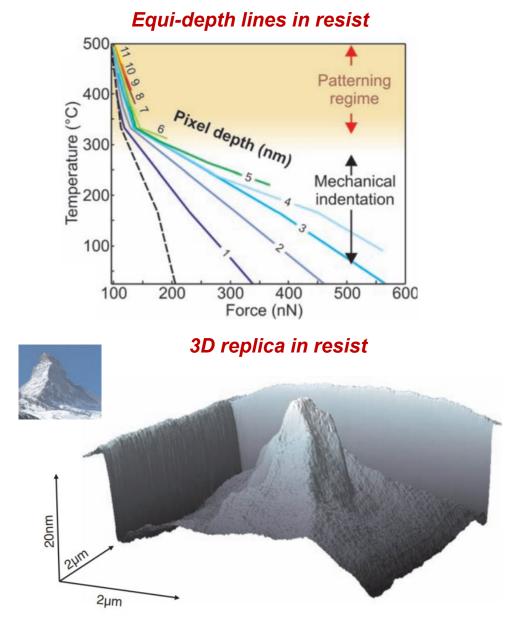
High-resolution

High-resolution

lift-off

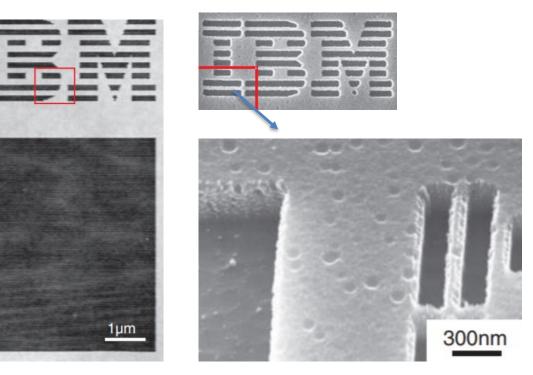
deep etching

3D nanostructures in resist and transfer in Si



Local desorption of a glassy organic resist. Smallest width in Si 30 nm, by first transferring the pattern into a SiO2 etch mask, and then performing a second etching step.

Pattern transfer in Si

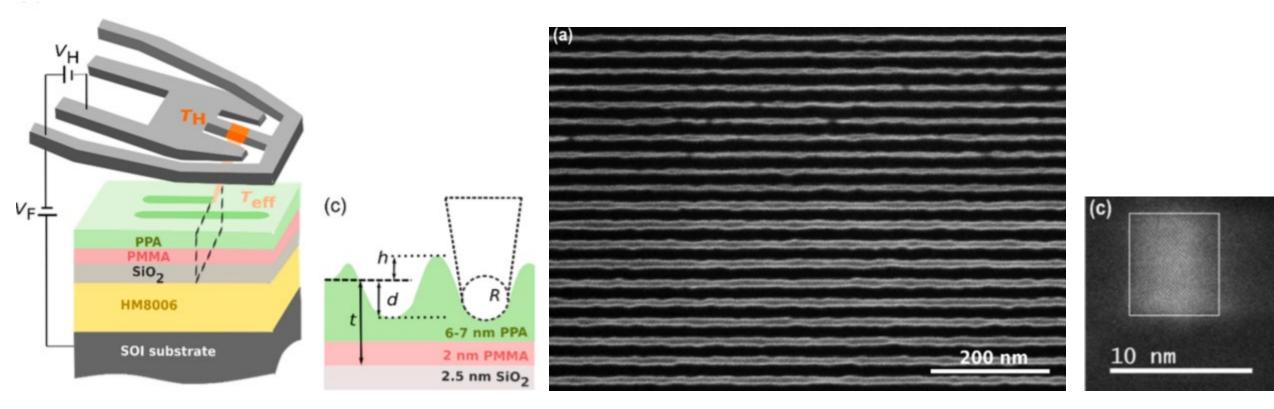


Science 328, 732-735 (2010).

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Sub-10 nm features in Si via pattern transfer

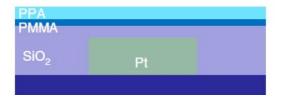
Thin lines in polyphthalaldehyde (PPA) layer, then transferred into Si. The best pattern geometry is obtained at a heater temperature of ~600 °C, which is below or close to the transition from mechanical indentation to thermal evaporation. For the 14 nm half-pitch lines in silicon, a line edge roughness of 2.6 nm (3 σ), and a feature size of the patterned walls of 7 nm (12 nm thick Si).



ACS Nano 2017, 11, 11890-11897

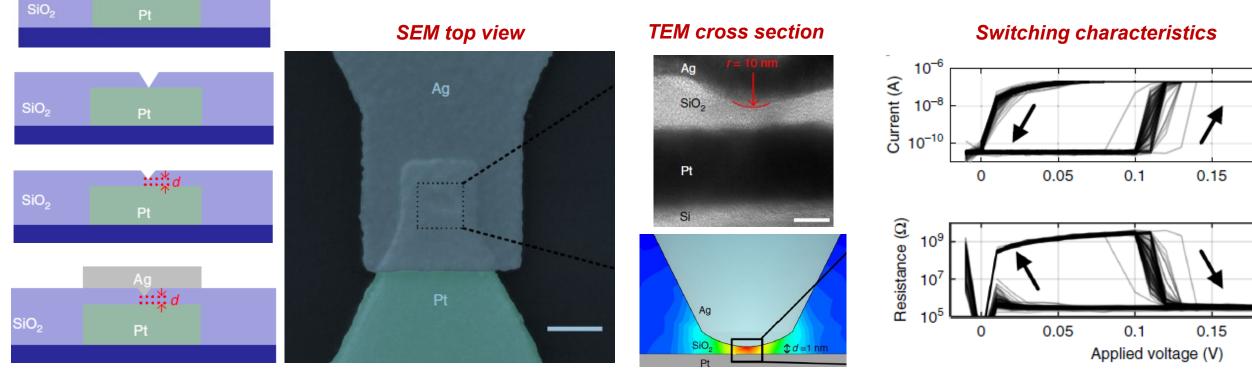
Atomic scale memristor fabrication

Fabrication process



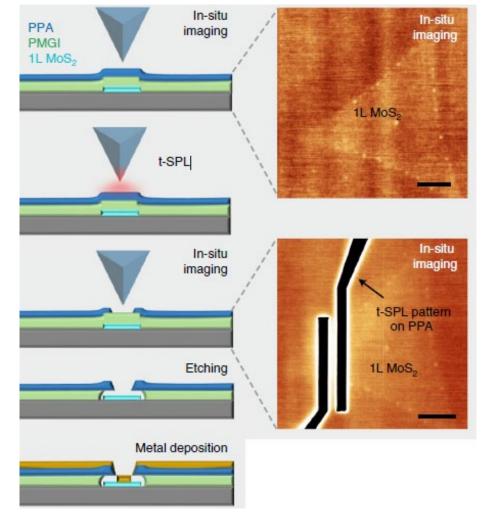
PMMA

Tip-shaped structure patterned via t-SPL. Highly confined electric field at nanometer size and feature low switching voltage around 100 mV, operation speed in the nanosecond range, extinction resistance ratio as high as 6×105 , reliable operations despite its atomic scale dimensions, and the possibility to a achieve multi-level behavior.



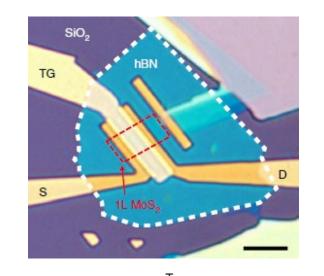
Commun. Phys. 2, 28 (2019)

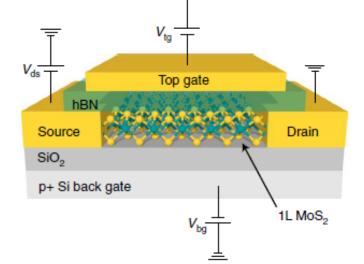
Field effect transistors based on MoS₂



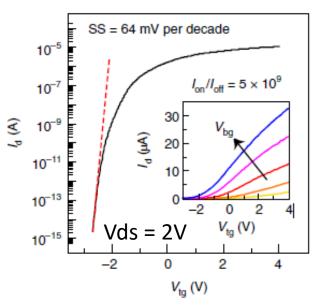
Fabrication process







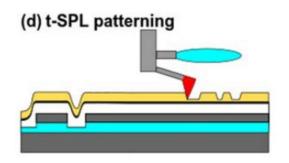
Transfer curve



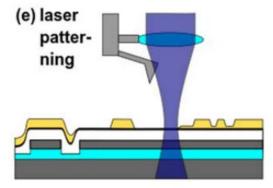
X. Zheng.. EA et al. Nat. Electron. 2, 17-25 (2019)

Quantum Dot Transistors via Hybrid t-SPL / laser writing

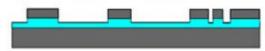
Fabrication process

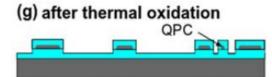


Room temperature (RT) single electron transistors (SETs) based on point-contact tunnel junctions. Electron localization within nanocrystals or phosphorous atoms embedded within the SiO2 allowed to reach tunneling behavior at RT.

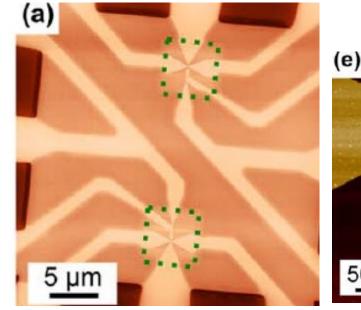


(f) after etch transfer

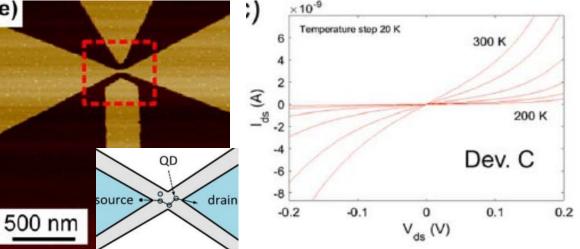




Hybrid Laser + t-SPL patterns

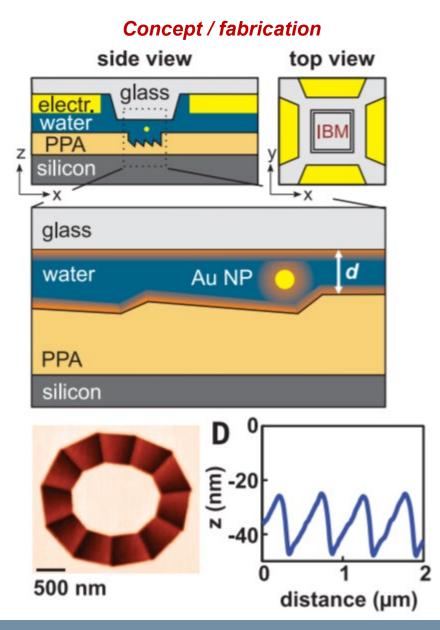


Tunnel dominated conduction at RT

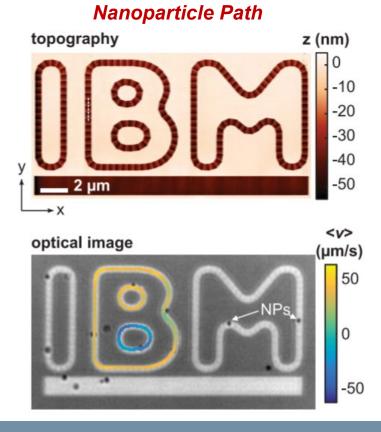


Nanotechnology 29, 505302 (2018).

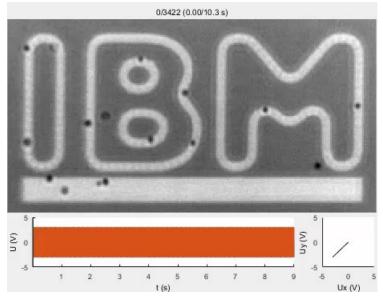
Nanofluidic Rocking Brownian motors for nanoparticle manipulation



Energy landscapes for nanoparticles by accurately shaping the geometry of a nanofluidic slit and exploiting the electrostatic interaction between like-charged particles and walls. Directed transport was performed by combining asymmetric potentials with an oscillating electric field to achieve a rocking Brownian motor.



Directed transport via rotating E field

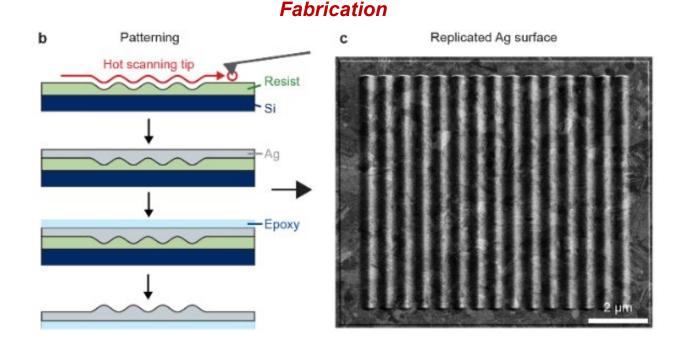


Science 359, 1505–1508 (2018).

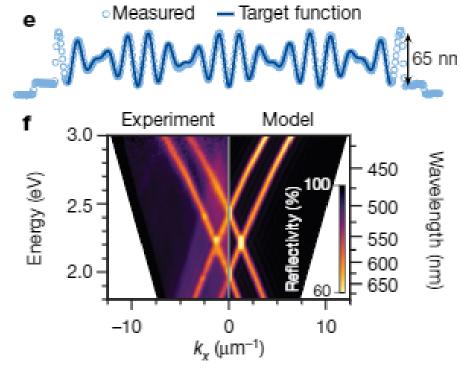
36

Optical Fourier Surfaces: 3D optical metasurfaces

The surface pattern generates a desired diffracted output through its Fourier transform. To shape the optical wavefront, **the ideal surface profile should contain a precise sum of sinusoidal waves**, each with a well defined amplitude, spatial frequency and phase.





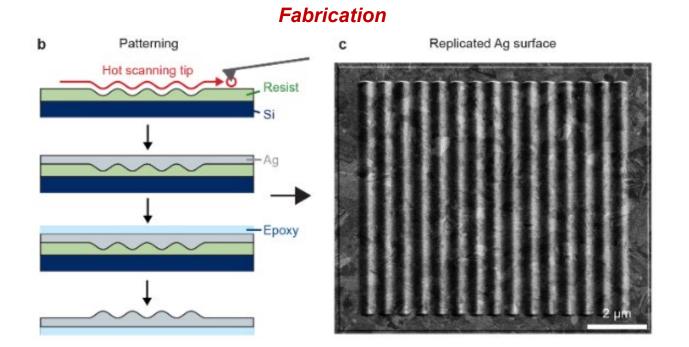


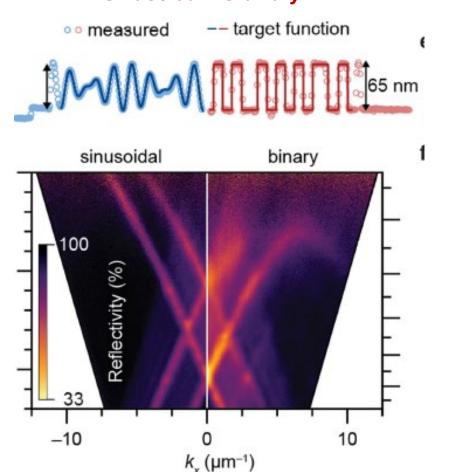
Nature 582, 506–510 (2020)

37

Optical Fourier Surfaces: 3D optical metasurfaces

The surface pattern generates a desired diffracted output through its Fourier transform. To shape the optical wavefront, **the ideal surface profile should contain a precise sum of sinusoidal waves**, each with a well defined amplitude, spatial frequency and phase. *Sinusoidal VS binary*





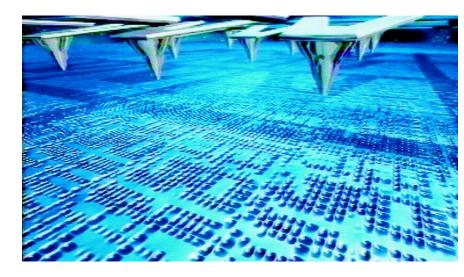
Nature 582, 506–510 (2020)

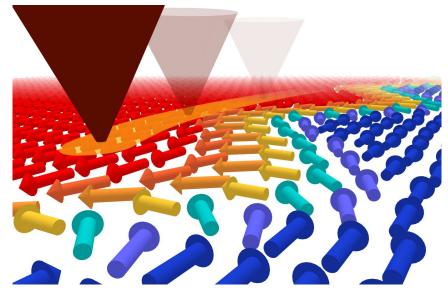
Outlook

- Scanning Probe Microscopy / Lithography
- Brief history of t-SPL: from milli-pedes to nano-structures
- Experimental: features and limitations of t-SPL

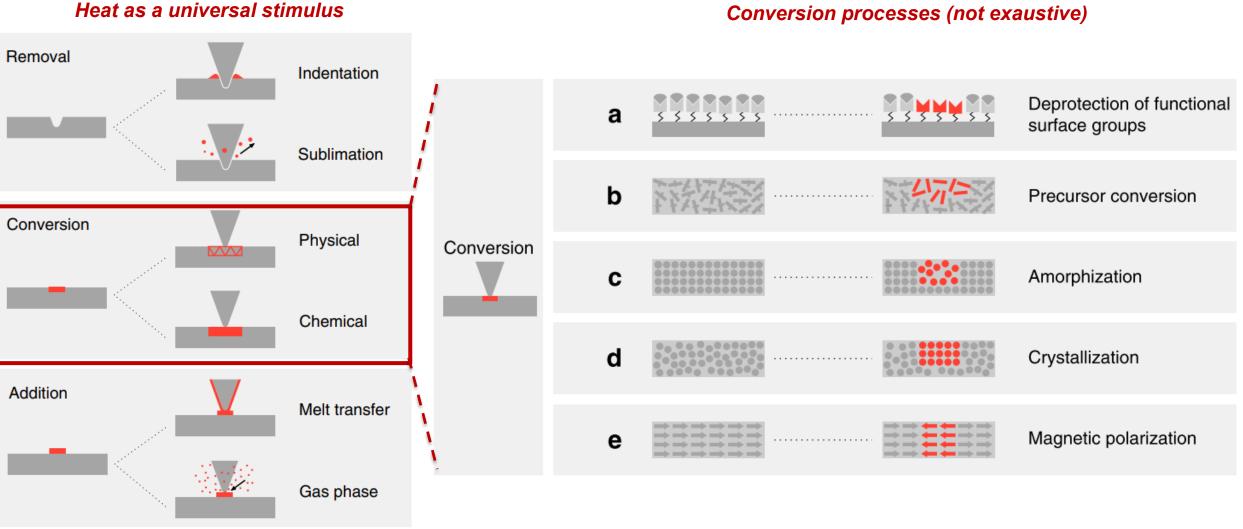
Applications:

- 1) REMOVAL Direct sublimation of organic resists / lithography
- 2) «CHEMICAL conversion» at the nanoscale
- 3) «PHYSICAL conversion»: t-SPL for magnetism





Direct material conversion



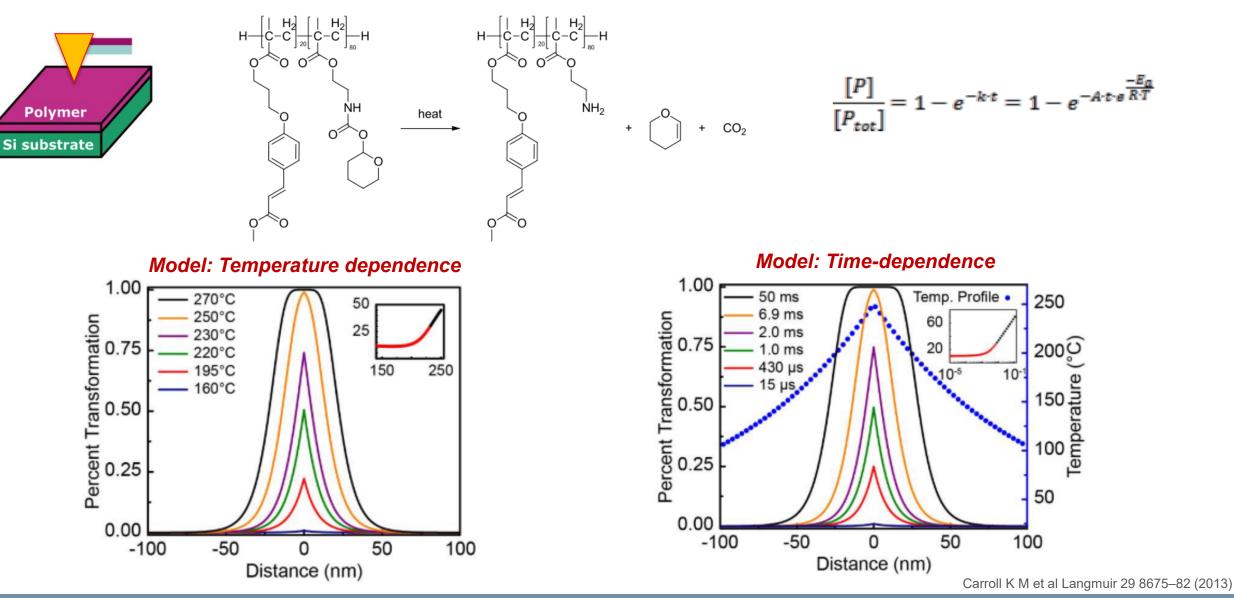
Conversion processes (not exaustive)

Howell et al. Microsystems & Nanoengineering (2020) 6:21

40

Controlled deprotection of functional groups

Thermally-induced deprotection of reactive amines

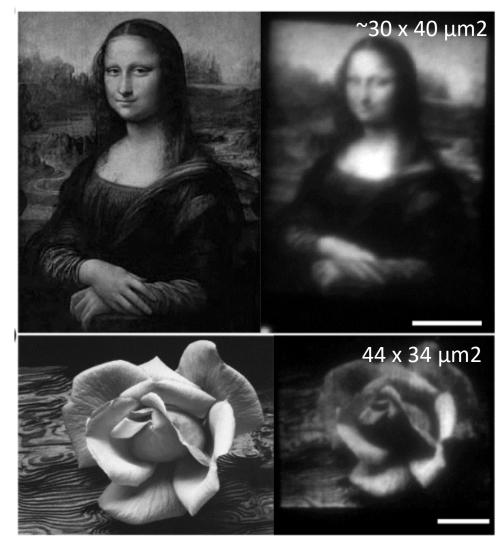


41

Controlled deprotection of functional groups

1.0 Peak Temperature (°C) 0.8 239 151 195 0.6 Experiment Relative Concentration 6 0.0 0.0 0.1 7 0.0 0.0 0.1 Model 0.4 0.2 0.0 1.0 0.8 0.6 0.4 0.2 0.0 10 8 6 0.0 Power (mw)

Grayscale map of amine concentration

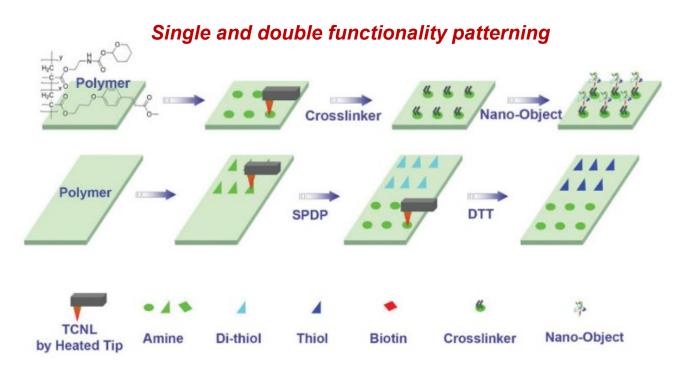


Exp: Controlled amine gradients

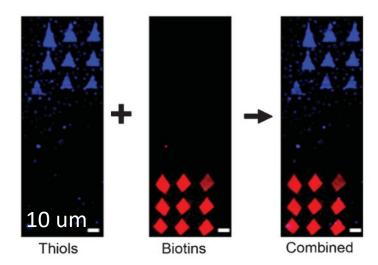
Carroll K M et al Langmuir 29 8675–82 (2013)

Controlled immobilization of multiple nano-objects

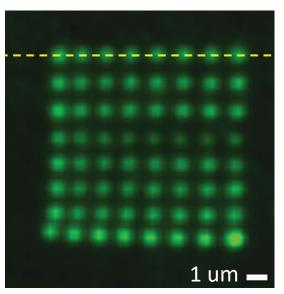
Nanoscale chemical patterning of different chemical species (amine, thiol, aldehyde, and biotin) in independent nanopatterns is achieved by the iterative application of thermochemical nanolithography (TCNL) and control the surface positioning of patterns followed by their chemical conversion to other functional groups.



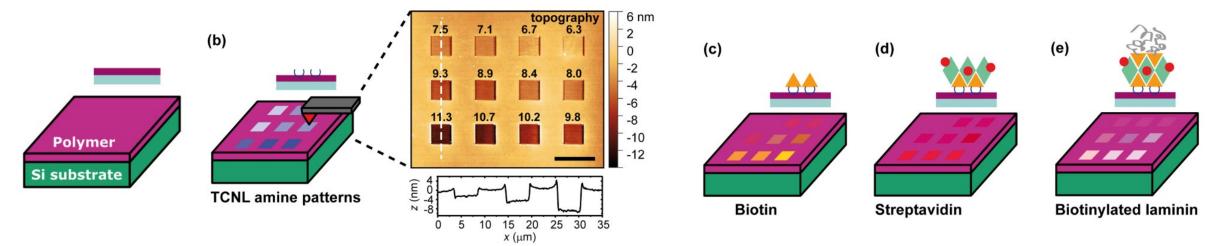
Wang et al. Adv. Funct. Mater. 19 3696–702 (2009)



Nanopatterning fibronectin arrays

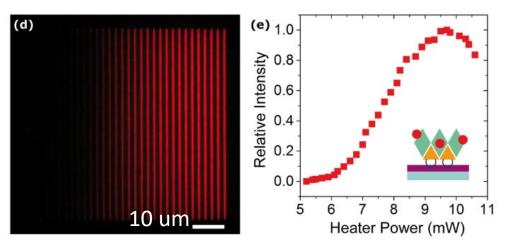


Immobilizing protein gradients with nanoscale resolution



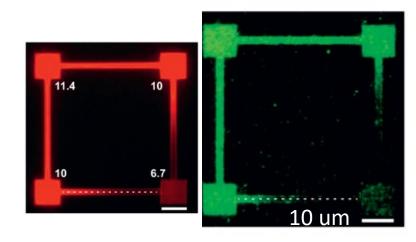
Protein immobilization process

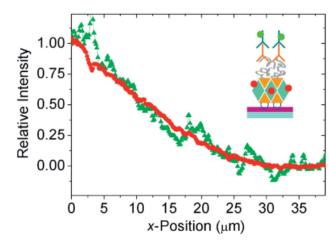
Fluo Streptavidin gradients



EA et al. Nanotechnology 27 315302 (2016)

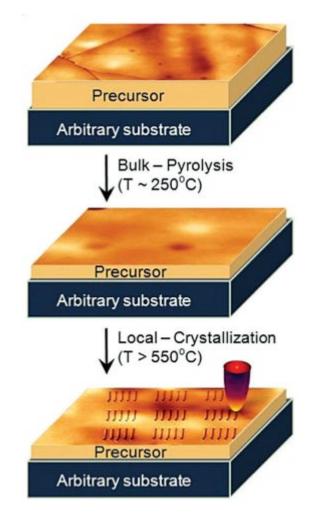
Fluo Streptavidin + Laminin gradients





Direct nanofabrication of ferroelectric nanostructures

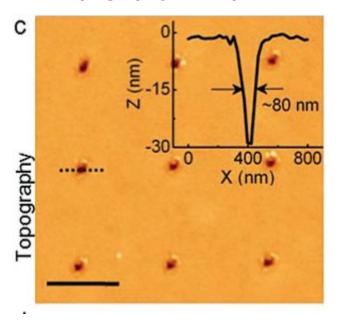
Fabrication process in PTO and PZT



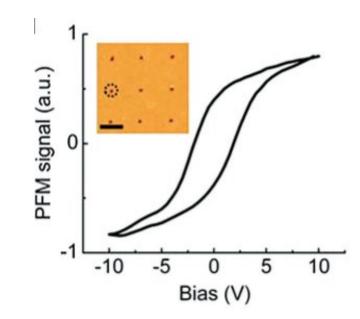
Kim S. Adv. Mater. 23 3786-90 (2011)

After deposition of a sol-gel precursor film of PZT and PTO and baking for removing the solvent, t-SPL is perform in order to locally crystallize the film into PZT or PTO. Tcryst > 550°C. The piezoelectric properties of the directly written nanostructures are measured via PFM.

Topography of FE patterns

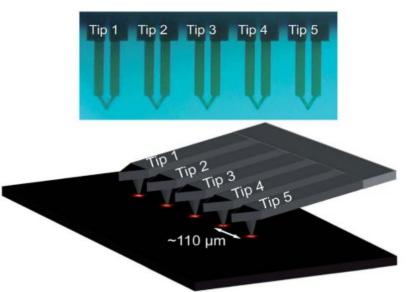


PFM hysteresis loop

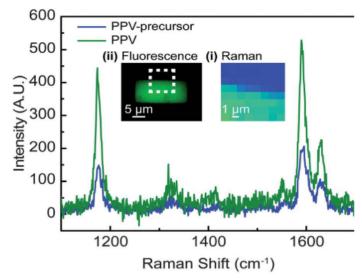


Parallelization via tip array: direct patterning of PPV nanostructures

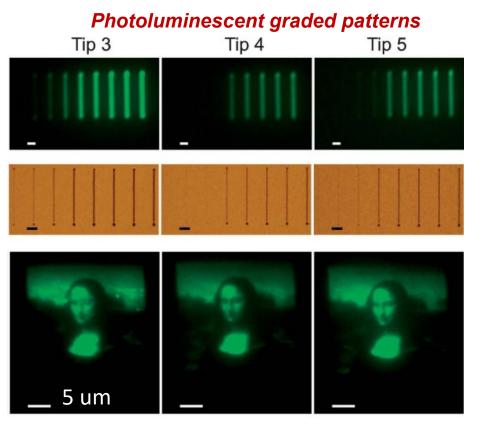
An array of 5 tips independently addressable was used for the fabrication of conjugated polymer nanostructures. A precursor film is locally heated and converted in PPV, which is a photo-luminescent semi-conducting organic polymer. The photoluminescence is controlled by the degree of conversion, related to temperature.



Leveled tip array



Micro Raman PPV fingerprints



Keith M. Carroll, Nanoscale, 2014, 6, 1299–1304

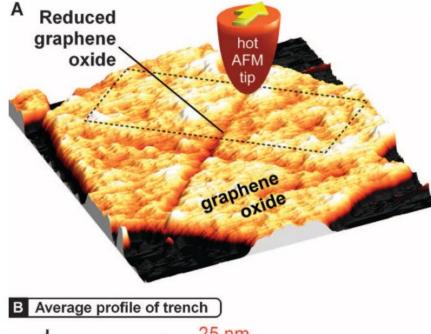
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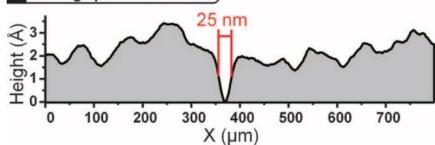
Thermal Scanning Probe Lithography

edoardo.albisetti@polimi.it

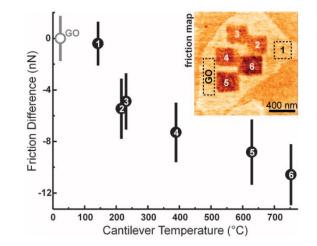
Tunable reduction of Graphene Oxide

Topography of reduced grOX

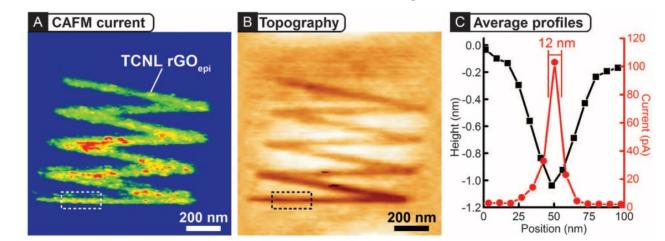




Tunable friction with temperature

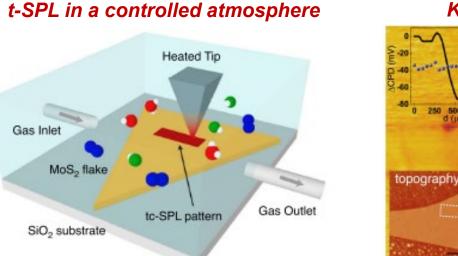


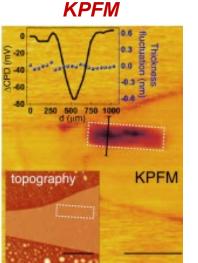
Nanoscale conductivity via C-AFM



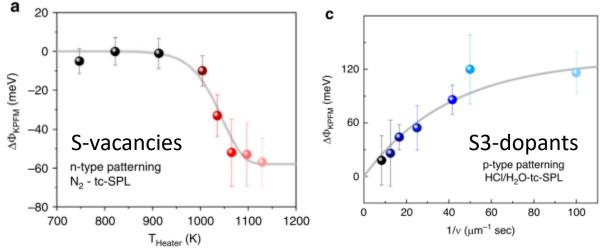
Wei Z, Science 328 1373–6 (2010)

Spatial defect nanoengineering in MoS2





n-type or p-type patterning



t-SPL in combination with a gas cell is used for generating defects in MoS2. Nanoscale control of defects in monolayer MoS2. The defects can present either p- or ntype doping on demand, depending on the gas used, allowing to realize p-n junctions.

S3 dopants in HRTEM

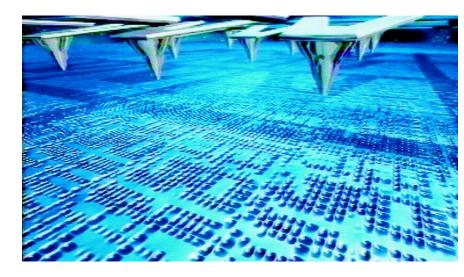
Zheng X, EA, et al Nat. Commun. 11 1–12 (2020)

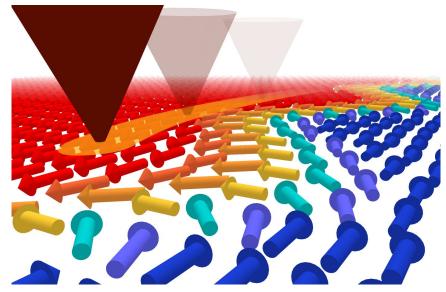
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- Experimental: features and limitations of t-SPL

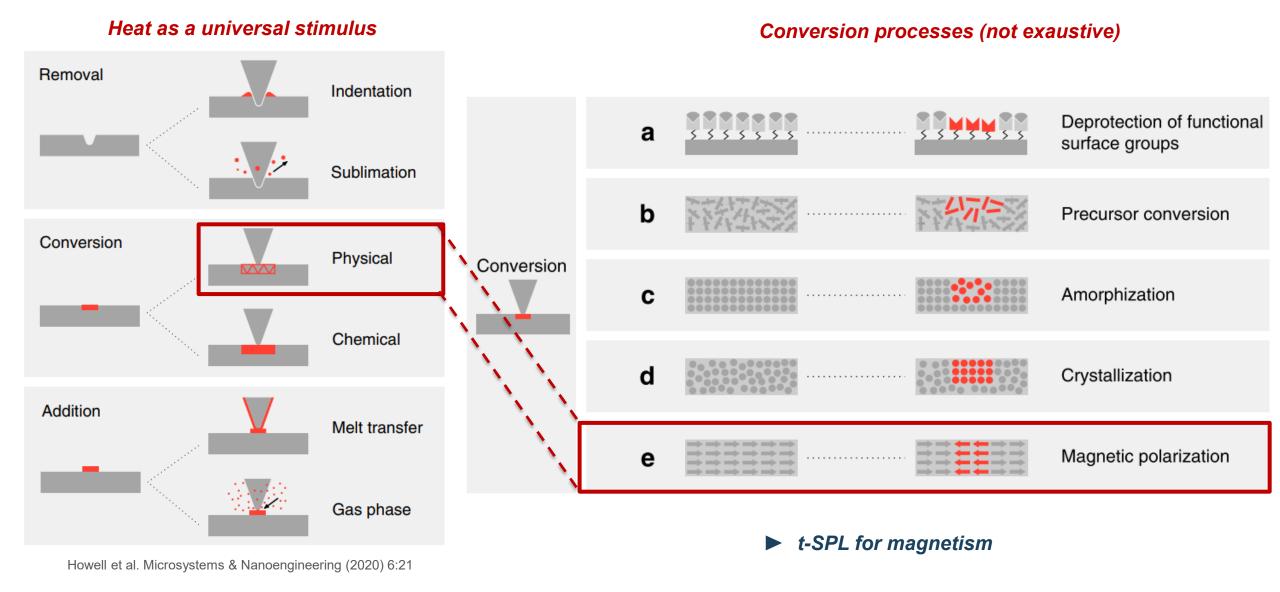
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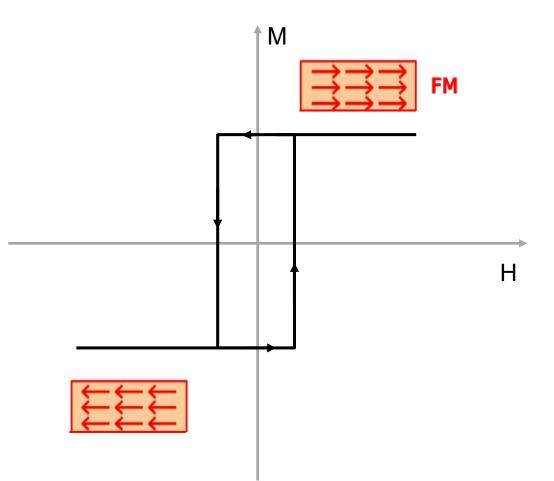


«Physical» material conversion: Nanopatterning Magnetism

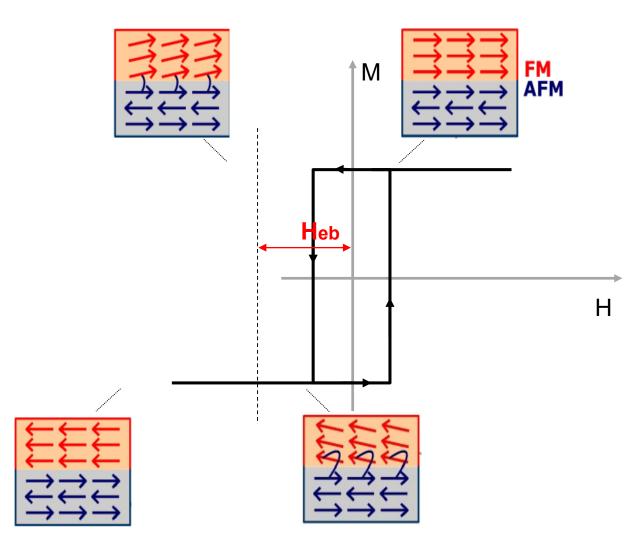


50

Exchange bias at the FM / AF interface

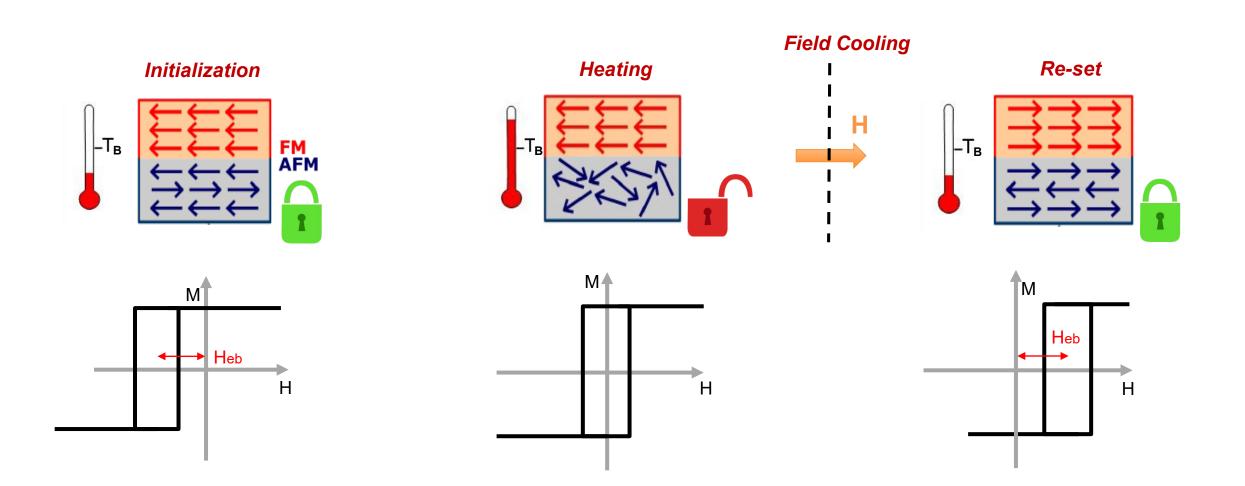


Exchange bias at the FM / AF interface

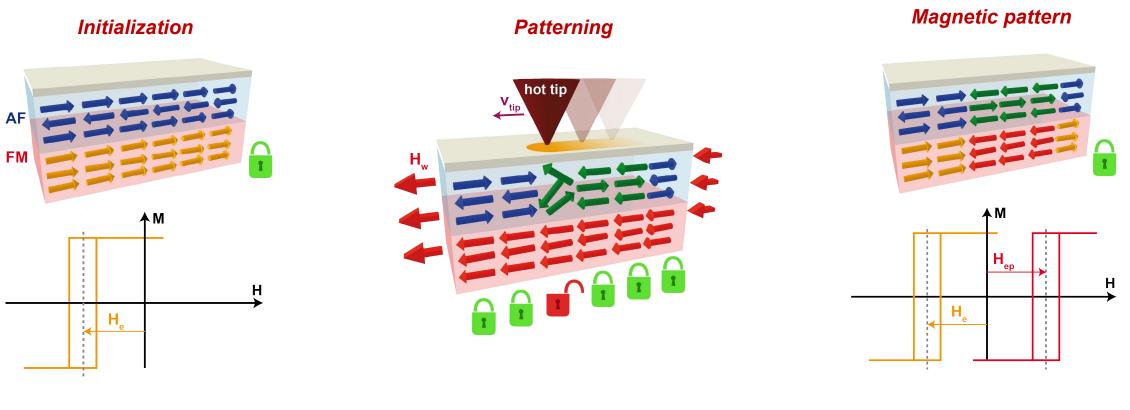




Setting the exchange bias with temperature



Thermally assisted magnetic Scanning Probe Lithography (tam-SPL)

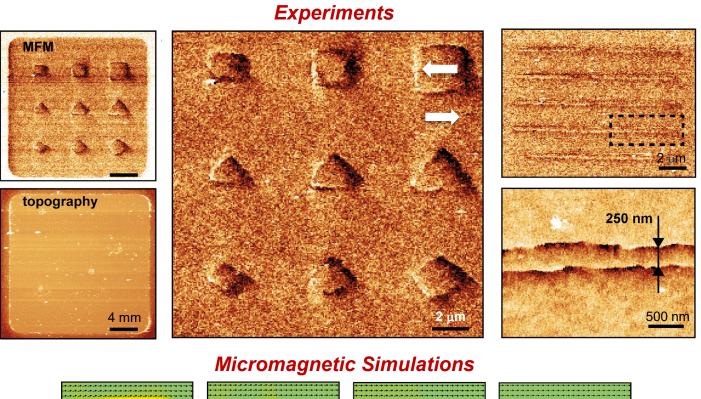


- Single step, non-destructive, ambient conditions
- Reconfigurable patterns (erase rewrite)
- Robust vs external fields
- Finely tunable

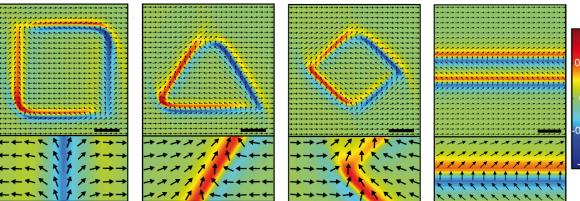
EA et al., Nat. Nanotech. 11, 545–551 (2016)

54

Patterning magnetic domains / domain walls







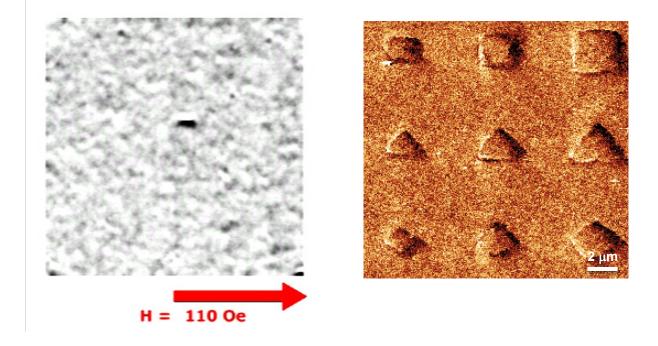
EA et al., Nat. Nanotech. 11, 545-551 (2016)

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Thermal Scanning Probe Lithography

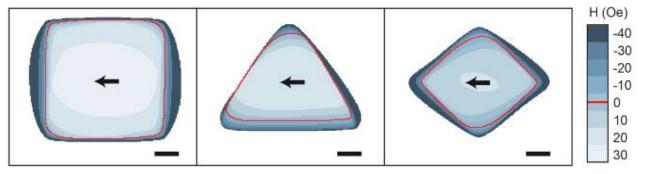
EA et al., J. Magn. Magn. Mater. **400** 230–235 (2016)

Spin-texture evolution with external field





Displacing domain walls with H, before switching



EA et al., Nat. Nanotech. 11, 545-551 (2016)

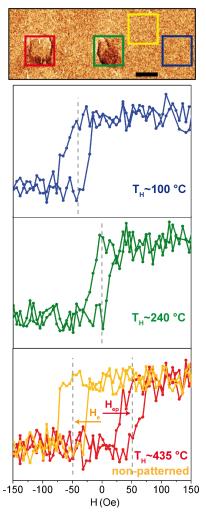
NanoLito 2021, University of Salamanca

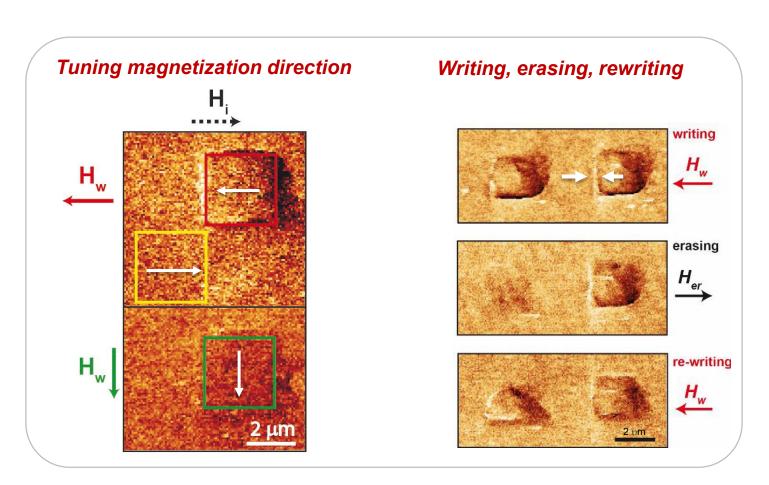
30/6/2021

w/t M. Pancaldi, P. Vavassori, CIC Nanogune, Spain

Writing / rewriting on a magnetic blackboard

Tuning EB strength



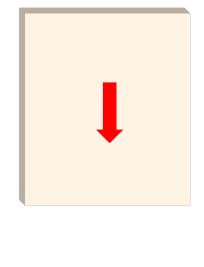


EA et al., Nat. Nanotech. 11, 545–551 (2016)

IrMn CoFeB

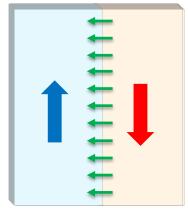
From 2D domains to 1D domain walls, to 0D topological solitons

IrMn CoFeB

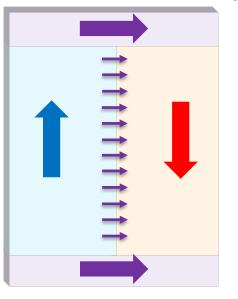


Uniform domain

Néel wall



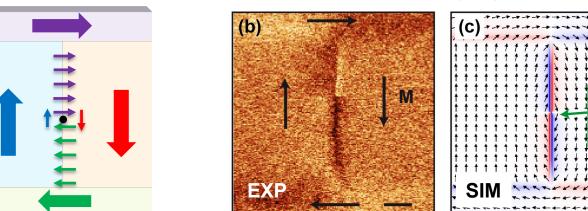
Néel wall with fixed chirality



Néel wall with Vortex Bloch Line

EA et al., Appl. Phys. Lett. 113, 162401 (2018)

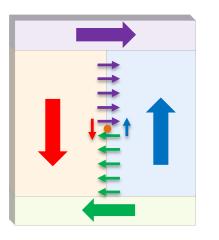
Deterministic control on position, vorticity and circularity

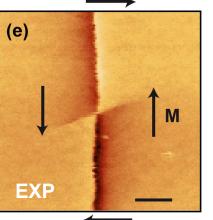


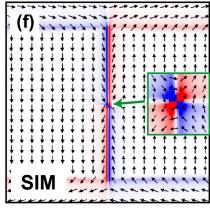
Vortex Bloch Line within Néel wall (CW)



Anti-Vortex Bloch Line within Néel wall





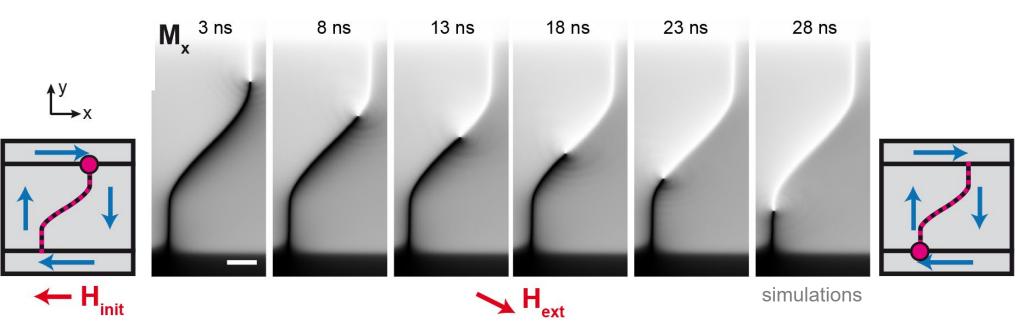


EA et al., Appl. Phys. Lett. 113, 162401 (2018)

Deterministic topology

Manipulation of magnetic solitons within tam-SPL DWs





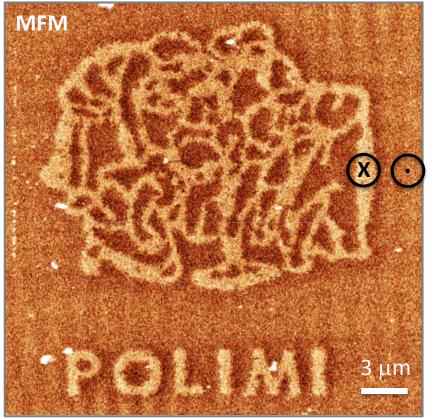
Vortex displacement along arbitrarily- shaped Néel wall



EA et al., Appl. Phys. Lett. 113, 162401 (2018)

Patterning out-of-plane EB, magnetization (..and skyrmion phase)

OOP complex domains

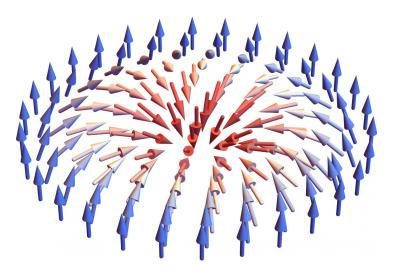


EA et al., unpublished





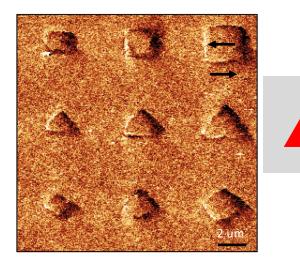
Topological textures e.g. Nèel Skyrmions



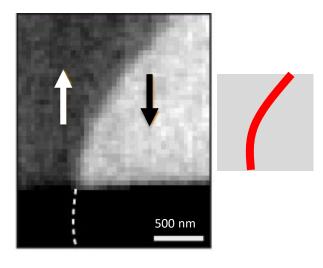
61

Summary: nanopatterning rewritable multidimensional spin-textures

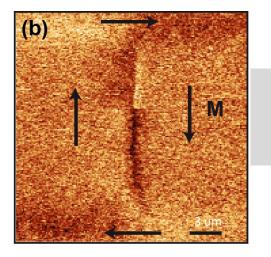
2D Magnetic domains



1D Domain walls



OD Topological solitons



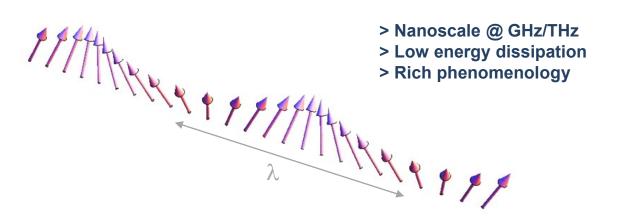


62

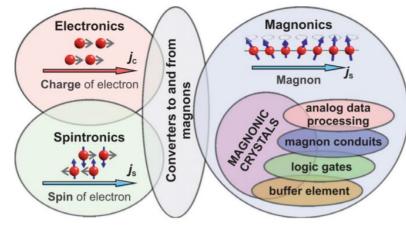
Applications of tam-SPL: manipulating spin-waves

Spin-waves

Magnonics

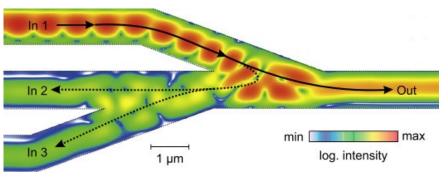


https://www.youtube.com/watch?v=pWQ3r-2Xjeo

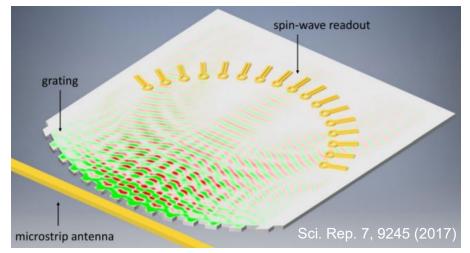


J. Phys. D: Appl. Phys. 50 (2017) 244001

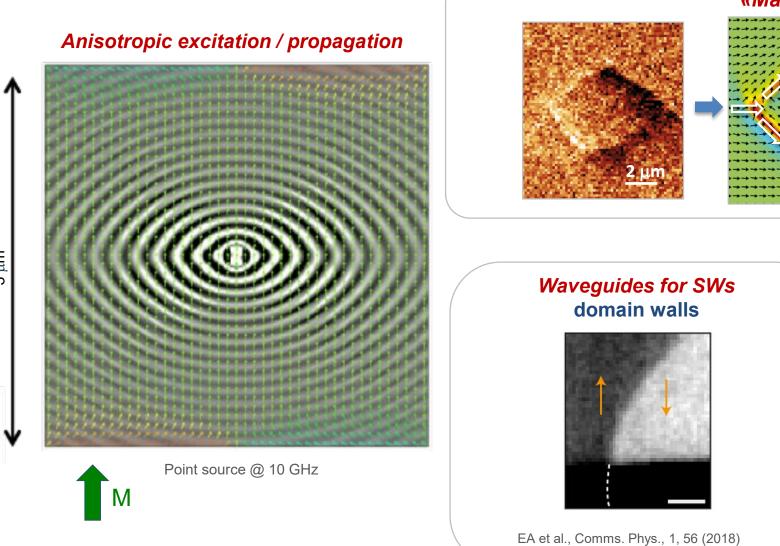
Computing with spin-waves (digital / analog)

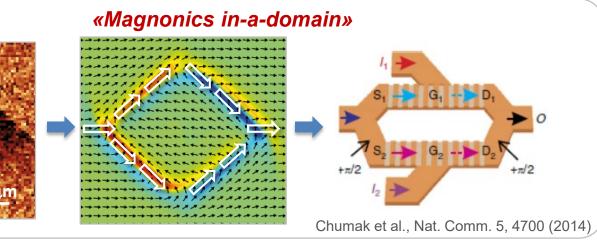


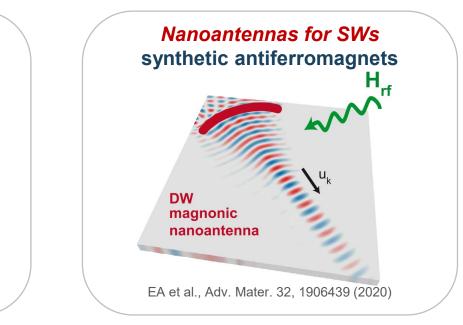
Physics Letters A 381 (2017) 1471–1476



Manipulating spin-waves with tam-SPL spin-textures



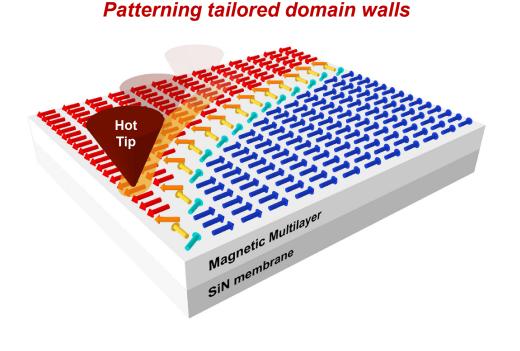




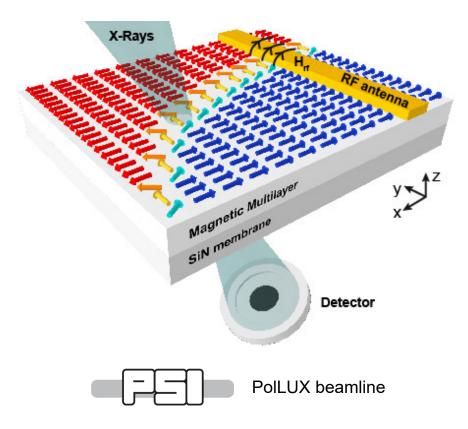
Thermal Scanning Probe Lithography

edoardo.albisetti@polimi.it

Nanoscale circuits for SWs based on domain walls



XMCD-STXM for SW visualization

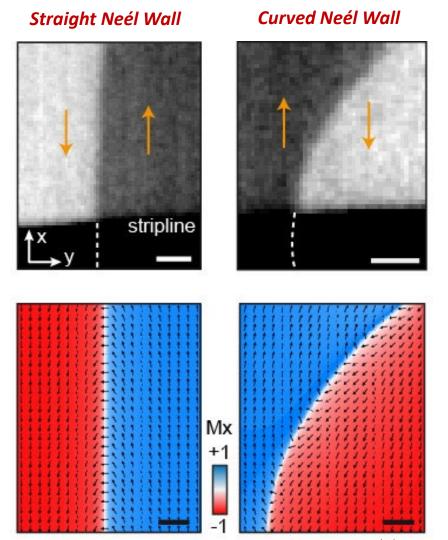


EA et al., Comms. Phys., 1, 56 (2018)

w/t S. Finizio, S. Wintz, J. Raabe, SLS-PSI, Switzerland

Patterned spin-textures: static STXM





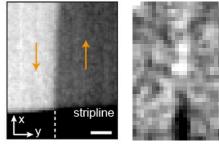
scale bars 500 nm

EA et al., Comms. Phys., 1, 56 (2018)

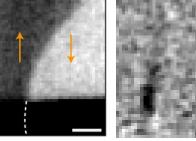
30/6/2021 NanoLito 2021, University of Salamanca

Guiding spin-waves with shaped walls

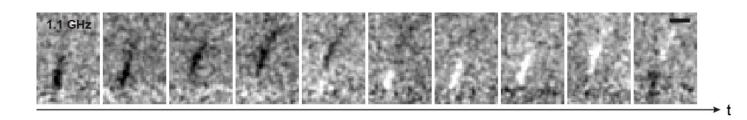


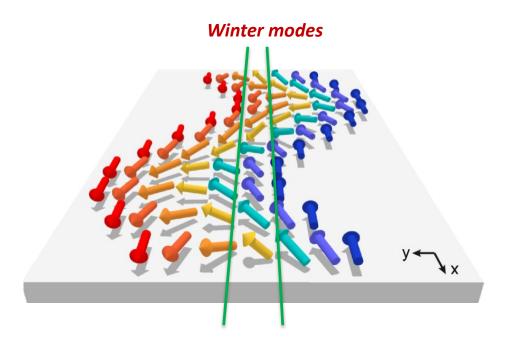


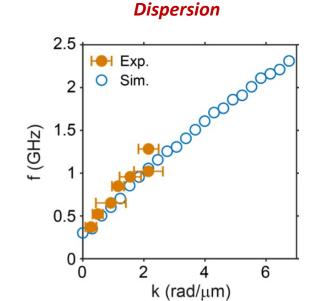
In-plane sensitivity



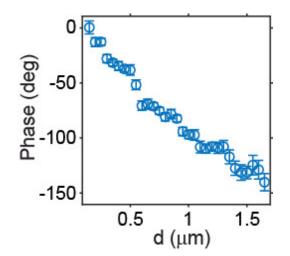
scale bars 500 nm







Propagating

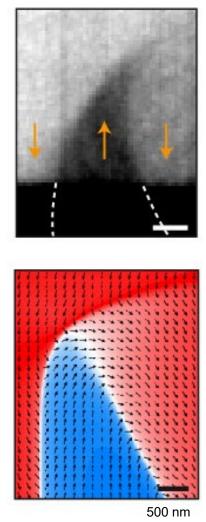


EA et al., Comms. Phys., 1, 56 (2018)

Domain wall-based spin wave circuit



2 Neel walls

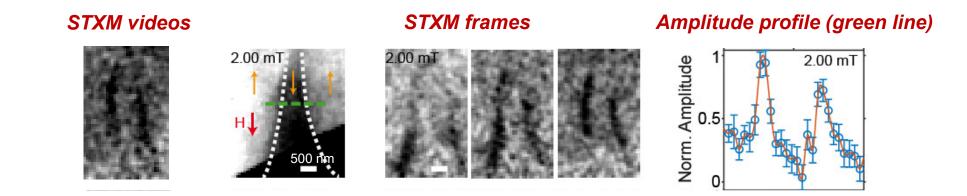


EA et al., Comms. Phys., 1, 56 (2018)

30/6/2021 NanoLito 2021, University of Salamanca

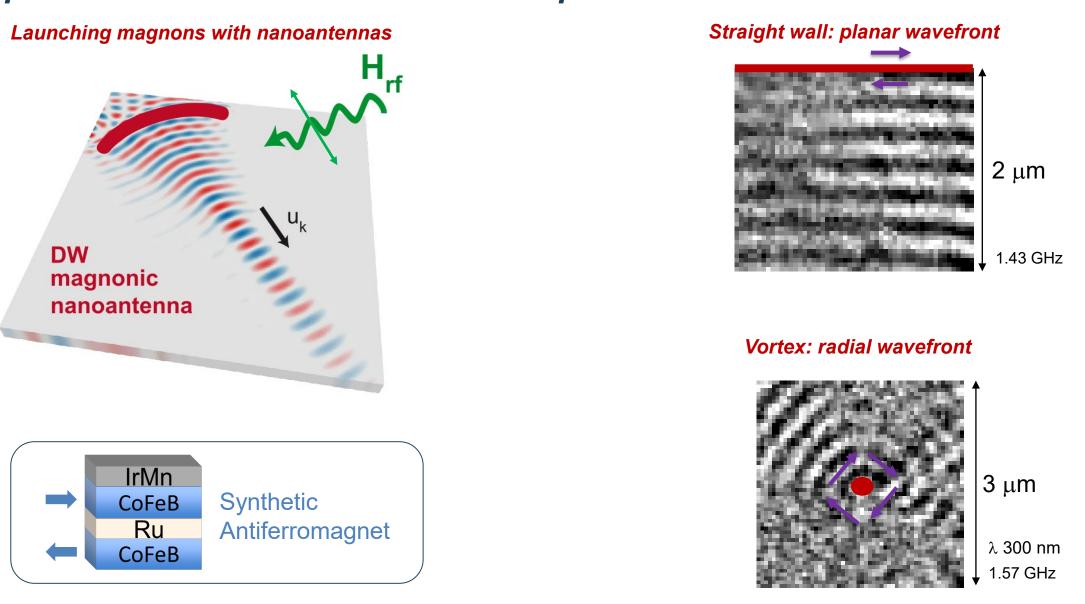
Tunable spatial superposition of guided modes





EA et al., Comms. Phys., 1, 56 (2018)

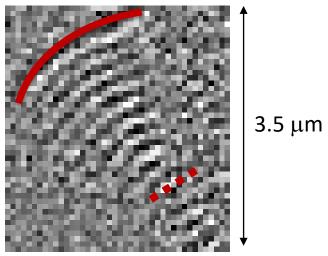
Spin-textures as nanoantennas for spin-waves



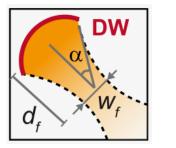
EA et al., Adv. Mater. 32, 1906439 (2020)

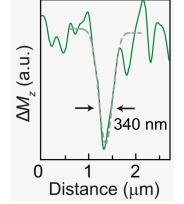
Spin-wave wavefront shaping with spin-texture emitters

Focusing SWs

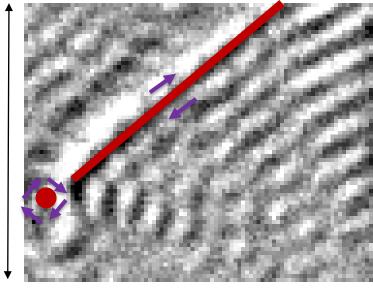








Interference pattern generation via multiple sources



1.29 GHz

... Towards integrated analog processing using SW

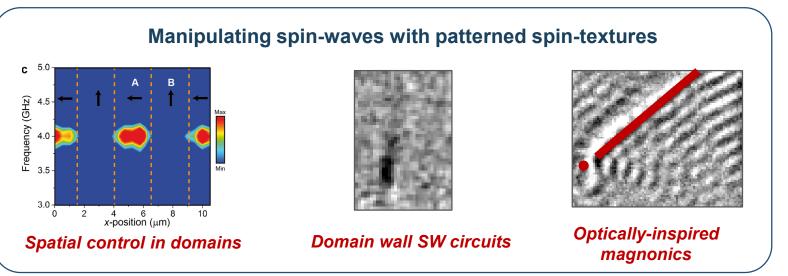
EA et al., Adv. Mater. 32, 1906439 (2020)

2.5 μm

Summary: tam-SPL and applications

Tailored, deterministic 2D-1D-0D spin-texturesImage: Spin





Thanks!



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Thermal Scanning Probe Lithography





Thanks for your attention



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Thermal Scanning Probe Lithography

Multiphoton Lithography: Techniques, Materials, and Applications, Wiley